

# ADP3209D

## 5-Bit, Programmable, Single-Phase, Synchronous Buck Controller

The ADP3209D is a highly efficient, single-phase, synchronous buck switching regulator controller. With its integrated drivers, the ADP3209D is optimized for converting the notebook battery voltage to render the supply voltage required by high performance Intel chipsets. An internal 5-bit DAC is used to read a VID code directly from the chipset and to set the GMCH core voltage to a value within the range of 0.4 V to 1.25 V.

The ADP3209D uses a multi-mode architecture. It provides programmable switching frequency that can be optimized for efficiency depending on the output current requirement. In addition, the ADP3209D includes a programmable load line slope function to adjust the output voltage as a function of the load current so that the core voltage is always optimally positioned for a load transient. The ADP3209D also provides accurate and reliable current overload protection and a delayed power-good output. The IC supports On-The-Fly (OTF) output voltage changes requested by the chipset.

The ADP3209D is specified over the extended commercial temperature range of 0°C to 100°C and is available in a 32-lead LFCSP.

### Features

- Single-Chip Solution
- Fully Compatible with the Intel® GMCH Chipset Voltage Regulator Specifications
- Integrated MOSFET Drivers
- Input Voltage Range of 3.3 V to 22 V
- $\pm 8$  mV Worst-Case Differentially Sensed Core Voltage Error
- Overtemperature
- Automatic Power-Saving Modes Maximize Efficiency During Light Load Operation
- Soft Transient Control Reduces Inrush Current and Audio Noise
- Independent Current Limit and Load Line Setting Inputs for Additional Design Flexibility
- Built-In Power-Good Masking Supports Voltage Identification (VID) OTF Transients
- 5-Bit, Digitally Programmable DAC with 0.4 V to 1.25 V Output
- Short-Circuit Protection with Latchoff Delay
- Output Current Monitor
- 32-Lead LFCSP
- This is a Pb-Free Device

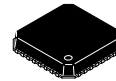
### Applications

- Notebook Power Supplies for Next-Generation Intel Chipsets



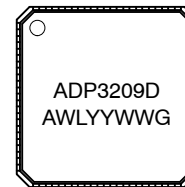
ON Semiconductor®

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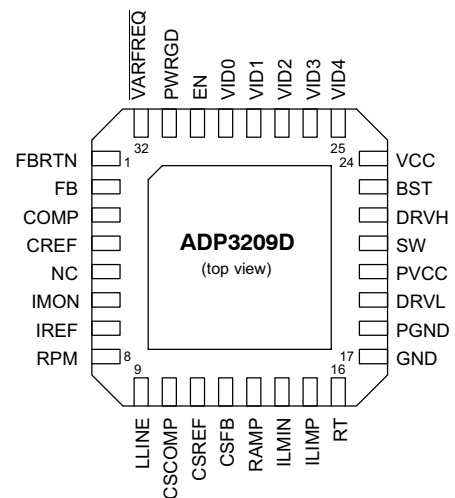
LFCSP32  
CASE 932AE

### MARKING DIAGRAM



A = Assembly Location  
WL = Wafer Lot  
YYWW = Date Code  
G = Pb-Free Package

### PIN ASSIGNMENT



### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 26 of this data sheet.

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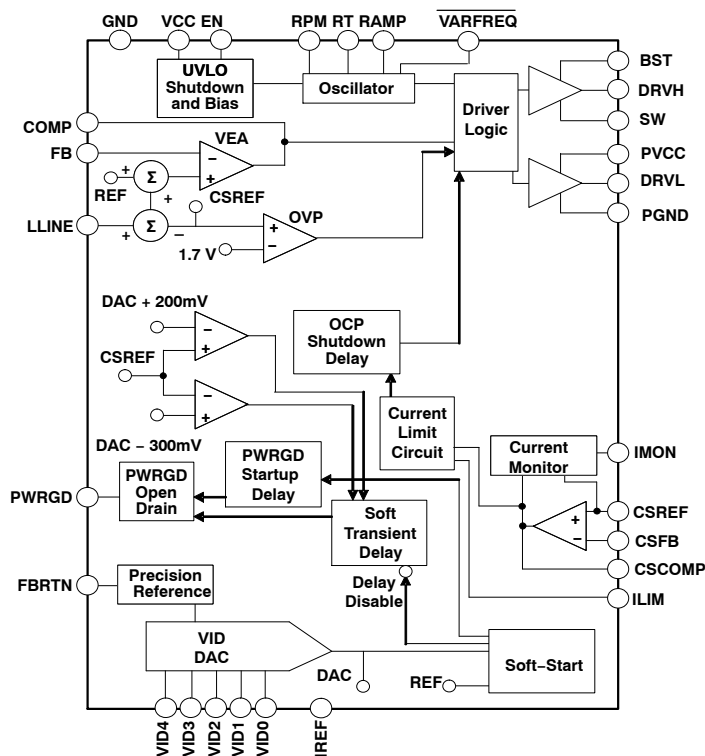


Figure 1. Functional Block Diagram

## ABSOLUTE MAXIMUM RATINGS

| Parameter                                                   | Rating                                       | Unit |
|-------------------------------------------------------------|----------------------------------------------|------|
| VCC                                                         | -0.3 to +6.0                                 | V    |
| FBRTN, PGND                                                 | -0.3 to +0.3                                 | V    |
| BST<br>DC<br>t < 200 ns                                     | -0.3 to +28<br>-0.3 to +33                   | V    |
| BST to SW<br>DC                                             | -0.3 to +6.0                                 | V    |
| SW<br>DC<br>t < 200 ns                                      | -5 to +22<br>-10 to +28                      | V    |
| DRVH to SW<br>DC                                            | -0.3 to +6.0                                 | V    |
| DRVL to PGND<br>DC<br>t < 200 ns                            | -0.3 to +6.0<br>-0.3 to +6.0<br>-5.0 to +6.0 | V    |
| RAMP (in Shutdown)                                          | -0.3 to +22                                  | V    |
| All Other Inputs and Outputs                                | -0.3 to +6.0                                 | V    |
| Storage Temperature                                         | -65 to +150                                  | °C   |
| Operating Ambient Temperature Range                         | 0 to 100                                     | °C   |
| Operating Junction Temperature                              | 125                                          | °C   |
| Thermal Impedance ( $\theta_{JA}$ ) 2-Layer Board           | 32.6                                         | °C/W |
| Lead Temperature<br>Soldering (10 sec)<br>Infrared (15 sec) | 300<br>260                                   | °C   |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

NOTE: This device is ESD sensitive. Use standard ESD precautions when handling.

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## PIN FUNCTION DESCRIPTIONS

| Pin No   | Mnemonic                    | Description                                                                                                                                                                                                                                                                                                                                                   |
|----------|-----------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 1        | FBRTN                       | Feedback Return Input/Output. This pin remotely senses the GMCH voltage. It is also used as the ground return for the VID DAC and the voltage error amplifier blocks.                                                                                                                                                                                         |
| 2        | FB                          | Voltage Error Amplifier Feedback Input. The inverting input of the voltage error amplifier.                                                                                                                                                                                                                                                                   |
| 3        | COMP                        | Voltage Error Amplifier Output and Frequency Compensation Point.                                                                                                                                                                                                                                                                                              |
| 4        | CREF                        | This pins sets the internal bias currents. Connect an 80kΩ resistor from either this pin or IREF pin to ground. If an 80 kΩ resistor is connected from this pin to ground, IREF pin must remain floating.                                                                                                                                                     |
| 5        | NC                          | Not Connected.                                                                                                                                                                                                                                                                                                                                                |
| 6        | IMON                        | Current Monitor Output. Open–drain output. This pin sources a current proportional to the output load current. A resistor from IMON to FBRTN sets the current monitor gain.                                                                                                                                                                                   |
| 7        | IREF                        | This pins sets the internal bias currents. Connect an 80 kΩ resistor from either this pin or CREF pin to ground. If an 80 kΩ resistor is connected from this pin to ground, CREF pin must remain floating.                                                                                                                                                    |
| 8        | RPM                         | RPM Mode Timing Control Input. An external resistor between this pin to ground sets the RPM mode turn–on threshold voltage.                                                                                                                                                                                                                                   |
| 9        | LLINE                       | Load Line Programming Input. The center point of a resistor divider connected between CSREF and CSCOMP can be tied to this pin to set the load line slope.                                                                                                                                                                                                    |
| 10       | CSCOMP                      | Current Sense Amplifier Output and Frequency Compensation Point.                                                                                                                                                                                                                                                                                              |
| 11       | CSREF                       | Current Sense Reference Input. This pin must be connected to the opposite side of the output inductor.                                                                                                                                                                                                                                                        |
| 12       | CSFB                        | Non–inverting Input of the Current Sense Amplifier. The combination of a resistor from the switch node to this pin and the feedback network from this pin to the CSCOMP pin sets the gain of the current sense amplifier.                                                                                                                                     |
| 13       | RAMP                        | PWM Ramp Slope Setting Input. An external resistor from the converter input voltage node to this pin sets the slope of the internal PWM stabilizing ramp.                                                                                                                                                                                                     |
| 14       | ILIMN                       | Current Limit Set Point. An external resistor between ILIMN and ILIMP sets the current limit set point.                                                                                                                                                                                                                                                       |
| 15       | ILIMP                       | Current Limit Set Point. An external resistor between ILIMN and ILIMP sets the current limit set point.                                                                                                                                                                                                                                                       |
| 16       | RT                          | PWM Oscillator Frequency Setting Input. An external resistor from this pin to GND sets the PWM oscillator frequency.                                                                                                                                                                                                                                          |
| 17       | GND                         | Analog and Digital Signal Ground.                                                                                                                                                                                                                                                                                                                             |
| 18       | PGND                        | Low–Side Driver Power Ground. This pin should be connected close to the source of the lower MOSFET(s).                                                                                                                                                                                                                                                        |
| 19       | DRVL                        | Low–Side Gate Drive Output.                                                                                                                                                                                                                                                                                                                                   |
| 20       | PVCC                        | Power Supply Input/Output of Low–Side Gate Driver.                                                                                                                                                                                                                                                                                                            |
| 21       | SW                          | Current Return For High–Side Gate Drive.                                                                                                                                                                                                                                                                                                                      |
| 22       | DRVH                        | High–Side Gate Drive Output.                                                                                                                                                                                                                                                                                                                                  |
| 23       | BST                         | High–Side Bootstrap Supply. A capacitor from this pin to SW holds the bootstrapped voltage while the high–side MOSFET is on.                                                                                                                                                                                                                                  |
| 24       | VCC                         | Power Supply Input/Output of the Controller.                                                                                                                                                                                                                                                                                                                  |
| 25 to 29 | VID4 to VID0                | Voltage Identification DAC Inputs. A 5–bit word (the VID code) programs the DAC output voltage, the reference voltage of the voltage error amplifier without a load (see the VID code table, Table 1). In normal operation mode, the VID DAC output programs the output voltage to a value within the 0 V to 1.25 V range. The input is actively pulled down. |
| 30       | EN                          | Enable Input. Driving this pin low shuts down the chip, disables the driver outputs, and pulls PWRGD low.                                                                                                                                                                                                                                                     |
| 31       | PWRGD                       | Power–Good Output. Open–drain output. A low logic state means that the output voltage is outside of the VID DAC defined range.                                                                                                                                                                                                                                |
| 32       | $\overline{\text{VARFREQ}}$ | Variable Frequency Enable Input. Pulling this pin to ground sets the normal RPM mode of operation. Pulling this pin to 5.0 V sets the fixed–frequency PWM mode of operation.                                                                                                                                                                                  |

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**ELECTRICAL CHARACTERISTICS**  $V_{CC} = 5.0V$ ,  $FBRTN = GND$ ,  $\overline{VARFREQ} = Low$ ,  $V_{VID} = 1.25 V$ ,  $T_A = -10^{\circ}C$  to  $100^{\circ}C$ , unless otherwise noted (Note 1). Current entering a pin (sunk by the device) has a positive sign.  $R_{REF} = 80 k\Omega$ .

| Parameter                                                | Symbol              | Conditions                                                                                                                              | Min  | Typ          | Max  | Unit       |
|----------------------------------------------------------|---------------------|-----------------------------------------------------------------------------------------------------------------------------------------|------|--------------|------|------------|
| <b>VOLTAGE CONTROL – Voltage Error Amplifier (VEAMP)</b> |                     |                                                                                                                                         |      |              |      |            |
| FB, LLINE Voltage Range (Note 2)                         | $V_{FB}, V_{LLINE}$ | Relative to $CSREF = V_{DAC}$                                                                                                           | -200 |              | +200 | mV         |
| FB, LLINE Offset Voltage (Note 2)                        | $V_{OSVEA}$         | Relative to $CSREF = V_{DAC}$                                                                                                           | -0.5 |              | +0.5 | mV         |
| FB Bias Current (Note 2)                                 | $I_{FB}$            |                                                                                                                                         | -1.0 |              | +1.0 | $\mu A$    |
| LLINE Bias Current                                       | $I_{LL}$            |                                                                                                                                         | -50  |              | +50  | nA         |
| LLINE Positioning Accuracy                               | $V_{FB} - V_{VID}$  | Measured on FB relative to $V_{VID}$ , LLINE forced 80 mV below $CSREF$                                                                 | -78  | -80          | -82  | mV         |
| COMP Voltage Range (Note 2)                              | $V_{COMP}$          |                                                                                                                                         | 0.85 |              | 4.0  | V          |
| COMP Current                                             | $I_{COMP}$          | COMP = 2.0 V, $CSREF = V_{DAC}$<br>FB forced 200 mV below $CSREF$<br>FB forced 200 mV above $CSREF$                                     |      | -0.75<br>3.0 |      | mA         |
| COMP Slew Rate                                           | $SR_{COMP}$         | $C_{COMP} = 10 pF$ , $CSREF = V_{DAC}$ ,<br>Open loop configuration<br>FB forced 200 mV below $CSREF$<br>FB forced 200 mV above $CSREF$ |      | 15<br>-20    |      | V/ $\mu s$ |
| Gain Bandwidth (Note 2)                                  | GBW                 | Non-inverting unit gain configuration, $R_{FB} = 1 k\Omega$                                                                             |      | 20           |      | MHz        |

## VID DAC VOLTAGE REFERENCE

|                                               |                    |                                                                                                                            |      |                      |      |              |
|-----------------------------------------------|--------------------|----------------------------------------------------------------------------------------------------------------------------|------|----------------------|------|--------------|
| $V_{DAC}$ Voltage Range (Note 3)              |                    | See VID Code Table                                                                                                         | 0    |                      | 1.5  | V            |
| $V_{DAC}$ Accuracy                            | $V_{FB} - V_{VID}$ | Measured on FB (includes offset), relative to $V_{VID}$ , for VID table see Table 1, $T_A = -10^{\circ}C$ to $85^{\circ}C$ | -6.0 |                      | +6.0 | mV           |
| $V_{DAC}$ Differential Non-linearity (Note 2) |                    |                                                                                                                            | -1.0 |                      | +1.0 | LSB          |
| $V_{DAC}$ Line Regulation                     | $\Delta V_{FB}$    | $V_{CC} = 4.75 V$ to $5.25 V$                                                                                              |      | 0.05                 |      | %            |
| Soft-Start Delay (Note 2)                     | $t_{SS}$           | Measured from EN pos edge to $FB = 1.25 V$ within 5%                                                                       |      | 1.8                  |      | ms           |
| $V_{DAC}$ Slew Rate                           |                    | Soft-Start<br>Non-LSB VID step                                                                                             |      | 0.0312<br>5.0<br>0.5 |      | LSB/ $\mu s$ |
| FBRTN Current                                 | $I_{FBRTN}$        |                                                                                                                            |      | 70                   | 200  | $\mu A$      |

## VOLTAGE MONITORING AND PROTECTION – Power Good

|                                          |               |                                                                    |      |             |      |         |
|------------------------------------------|---------------|--------------------------------------------------------------------|------|-------------|------|---------|
| CSREF Undervoltage Threshold             | $V_{UVCSREF}$ | Relative to nominal DAC Voltage                                    | -360 | -300        | -240 | mV      |
| CSREF Overvoltage Threshold              | $V_{OVCSREF}$ | Relative to nominal DAC Voltage                                    | 80   | 200         | 250  | mV      |
| CSREF Crowbar Voltage Threshold (Note 2) | $V_{CBCSREF}$ | Relative to FBRTN                                                  | 1.57 | 1.7         | 1.78 | V       |
| CSREF Reverse Voltage Threshold          | $V_{RVCSREF}$ | Relative to FBRTN, Latchoff mode:<br>CSREF Falling<br>CSREF Rising | -350 | -300<br>-75 | -5.0 | mV      |
| PWRGD Low Voltage                        | $V_{PWRGD}$   | $I_{PWRGD(SINK)} = 4 mA$                                           |      | 50          | 150  | mV      |
| PWRGD High, Leakage Current              | $I_{PWRGD}$   | $V_{PWRGD} = 5.0 V$                                                |      |             | 0.1  | $\mu A$ |
| PWRGD Startup Delay                      | $T_{SSPWRGD}$ | Measured from EN pos edge to PWRGD pos edge                        |      | 2.0         |      | ms      |

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3. Timing is referenced to the 90% and 10% points, unless otherwise noted.

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**ELECTRICAL CHARACTERISTICS**  $V_{CC} = 5.0V$ , FBRTN = GND,  $\overline{VARFREQ} = \text{Low}$ ,  $V_{VID} = 1.25V$ ,  $T_A = -10^\circ\text{C}$  to  $100^\circ\text{C}$ , unless otherwise noted (Note 1). Current entering a pin (sunk by the device) has a positive sign.  $R_{REF} = 80\text{ k}\Omega$ .

| Parameter                                             | Symbol          | Conditions                                                            | Min | Typ | Max | Unit          |
|-------------------------------------------------------|-----------------|-----------------------------------------------------------------------|-----|-----|-----|---------------|
| <b>VOLTAGE MONITORING AND PROTECTION – Power Good</b> |                 |                                                                       |     |     |     |               |
| PWRGD Latchoff Delay                                  | $T_{LOFFPWRGD}$ | Measured from Out-off-Good-Window event to Latchoff (switching stops) |     | 8.0 |     | ms            |
| PWRGD Propagation Delay (Note 3)                      | $T_{PDPWRGD}$   | Measured from Out-off-Good-Window event to PWRGD neg edge             |     | 200 |     | ns            |
| Crowbar Latchoff Delay (Note 2)                       | $T_{LOFFCB}$    | Measured from Crowbar event to Latchoff (switching stops)             |     | 200 |     | ns            |
| PWRGD Masking Time                                    |                 | Triggered by any VID change or OCP event                              |     | 100 |     | $\mu\text{s}$ |
| CSREF Soft-Stop Resistance                            |                 | EN = L or Latchoff condition                                          |     | 70  |     | $\Omega$      |

## CURRENT CONTROL – Current Sense Amplifier (CSAMP)

|                                         |                                        |                                                                                                   |              |             |              |                     |
|-----------------------------------------|----------------------------------------|---------------------------------------------------------------------------------------------------|--------------|-------------|--------------|---------------------|
| CSSUM, CSREF Common-Mode Range (Note 2) |                                        | Voltage range of interest                                                                         | 0            |             | 2.0          | V                   |
| CSSUM, CSREF Offset Voltage             | $V_{OSCSA}$                            | CSREF – CSSUM, $T_A = 25^\circ\text{C}$<br>$T_A = -10^\circ\text{C}$ to $85^\circ\text{C}$        | -0.5<br>-1.6 |             | +0.5<br>+1.6 | mV                  |
| CSSUM Bias Current                      | $I_{BCSSUM}$                           |                                                                                                   | -50          |             | +50          | nA                  |
| CSREF Bias Current                      | $I_{BCSREF}$                           |                                                                                                   | -2.0         |             | +2.0         | $\mu\text{A}$       |
| CSCOMP Voltage Range (Note 2)           |                                        | Voltage range of interest                                                                         | 0.05         |             | 2.0          | V                   |
| CSCOMP Current                          | $I_{CSCOMPsource}$<br>$I_{CSCOMPsink}$ | CSCOMP = 2.0 V<br>CSSUM forced 200 mV below CSREF<br>CSSUM forced 200 mV above CSREF              |              | -470<br>1.0 |              | $\mu\text{A}$<br>mA |
| CSCOMP Slew Rate                        |                                        | $C_{CSCOMP} = 10\text{ pF}$<br>CSSUM forced 200 mV below CSREF<br>CSSUM forced 200 mV above CSREF |              | 10<br>-10   |              | V/ $\mu\text{s}$    |
| Gain Bandwidth (Note 2)                 | $GBW_{CSA}$                            | Non-inverting unit gain configuration, $R_{FB} = 1\text{ k}\Omega$                                |              | 20          |              | MHz                 |

## CURRENT MONITORING AND PROTECTION

|                                               |                   |                                                                                                                                                       |                   |                |                      |    |
|-----------------------------------------------|-------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------|----------------|----------------------|----|
| Current Reference $I_{REF}$ Voltage           | $V_{REF}$         | $R_{REF} = 80\text{ k}\Omega$ to set $I_{REF} = 20\text{ }\mu\text{A}$                                                                                | 1.55              | 1.6            | 1.65                 | V  |
| Current Limiter (OCP) Current Limit Threshold | $V_{LIMTH}$       | Measured from CSCOMP to CSREF, $R_{LIM} = 4.5\text{ k}\Omega$                                                                                         | -70               | -90            | -110                 | mV |
| Current Limit Latchoff Delay                  |                   | Measured from OCP event to PWRGD de-assertion                                                                                                         |                   | 2.0            |                      | ms |
| Current Monitor Current Gain Accuracy         | $I_{MON}/I_{LIM}$ | Measured from $I_{LIM}$ to $I_{MON}$<br>$I_{LIM} = -20\text{ }\mu\text{A}$<br>$I_{LIM} = -10\text{ }\mu\text{A}$<br>$I_{LIM} = -5\text{ }\mu\text{A}$ | 9.4<br>9.2<br>9.0 | 10<br>10<br>10 | 10.7<br>11.0<br>11.3 |    |
| $I_{MON}$ Clamp Voltage                       | $V_{MAXMON}$      | Relative to FBRTN                                                                                                                                     | 1.0               |                | 1.15                 | V  |

## PULSE WIDTH MODULATOR – Clock Oscillator

|                                    |           |                                                                                                                                                                             |                     |                    |                        |     |
|------------------------------------|-----------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------|--------------------|------------------------|-----|
| $R_T$ Voltage                      | $V_{RT}$  | $\overline{VARFREQ} = \text{Low}$ , $R_T = 120\text{ k}\Omega$ ,<br>$V_{VID} = 1.2500\text{ V}$<br>$\overline{VARFREQ} = \text{High}$<br>See also $V_{RT}(V_{VID})$ formula | 1.07<br>5.0<br>0.95 | 1.125<br>1.0       | 1.17<br>5.0<br>1.05    | V   |
| PWM Clock Frequency Range (Note 2) | $f_{CLK}$ | Operation of interest                                                                                                                                                       | 0.3                 |                    | 3.0                    | MHz |
| PWM Clock Frequency                | $f_{CLK}$ | $T_A = +25^\circ\text{C}$ , $V_{VID} = 1.2000\text{ V}$<br>$R_T = 73\text{ k}\Omega$ (Note 2)<br>$R_T = 125\text{ k}\Omega$<br>$R_T = 180\text{ k}\Omega$ (Note 2)          | 970<br>705<br>500   | 1270<br>830<br>600 | 157<br>0<br>955<br>750 | kHz |

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**ELECTRICAL CHARACTERISTICS**  $V_{CC} = 5.0V$ ,  $FBRTN = GND$ ,  $\overline{VARFREQ} = Low$ ,  $V_{VID} = 1.25 V$ ,  $T_A = -10^{\circ}C$  to  $100^{\circ}C$ , unless otherwise noted (Note 1). Current entering a pin (sunk by the device) has a positive sign.  $R_{REF} = 80 k\Omega$ .

| Parameter                                 | Symbol         | Conditions                                                                                                      | Min         | Typ             | Max         | Unit          |
|-------------------------------------------|----------------|-----------------------------------------------------------------------------------------------------------------|-------------|-----------------|-------------|---------------|
| <b>RAMP GENERATOR</b>                     |                |                                                                                                                 |             |                 |             |               |
| RAMP Voltage                              | $V_{RAMP}$     | EN = high, $I_{RAMP} = 30 \mu A$<br>EN = low                                                                    | 0.9         | 1.0<br>$V_{IN}$ | 1.1         | V             |
| RAMP Current Range (Note 2)               | $I_{RAMP}$     | EN = high<br>EN = low, RAMP = 19 V                                                                              | 1.0<br>-0.1 |                 | 100<br>+0.1 | $\mu A$       |
| <b>PWM COMPARATOR</b>                     |                |                                                                                                                 |             |                 |             |               |
| PWM Comparator Offset (Note 2)            | $V_{OSRPM}$    | $V_{RAMP} - V_{COMP}$                                                                                           | -3.0        |                 | +3.0        | mV            |
| <b>RPM COMPARATOR</b>                     |                |                                                                                                                 |             |                 |             |               |
| RPM Current                               | $I_{RPM}$      | $V_{VID} = 1.2 V$ , $R_T = 180 k\Omega$ , $\overline{VARFREQ} = Low$ ,<br>See also $I_{RPM}(R_T)$ formula       |             | -6.0            |             | $\mu A$       |
| RPM Comparator Offset (Note 2)            | $V_{OSRPM}$    | $V_{COMP} - (1 + V_{RPM})$                                                                                      | -3.0        |                 | 3.0         | mV            |
| <b>SWITCH AMPLIFIER</b>                   |                |                                                                                                                 |             |                 |             |               |
| SW Common Mode Range (Note 2)             | $V_{SW(X)CM}$  | Operating Range for current sensing                                                                             | -600        |                 | +200        | mV            |
| SW Resistance                             | $R_{SW(X)}$    | Measured from SW to PGND                                                                                        |             | 1.5             |             | $k\Omega$     |
| <b>ZERO CURRENT SWITCHING COMPARATOR</b>  |                |                                                                                                                 |             |                 |             |               |
| SW ZCS Threshold                          | $V_{DCM(SW1)}$ |                                                                                                                 |             | -6.0            |             | mV            |
| Masked Off Time                           | $t_{OFFMSKD}$  | Measured from DRVH neg edge to DRVH pos edge at max frequency of operation                                      |             | 600             |             | ns            |
| <b>SYSTEM I/O BUFFERS VID[4:0] INPUTS</b> |                |                                                                                                                 |             |                 |             |               |
| Input Voltage                             |                | Refers to driving signal level:<br>Logic low, $I_{sink} \geq 1 \mu A$<br>Logic high, $I_{source} \leq -5 \mu A$ | 1.7         |                 | 0.3         | V             |
| Input Current                             |                | $V = 0.2 V$ , VID[4:0] (active pulldown to GND)                                                                 |             | -1.0            |             | $\mu A$       |
| VID Delay Time (Note 2)                   |                | Any VID edge to FB change 10%                                                                                   | 200         |                 |             | ns            |
| <b>VARFREQ</b>                            |                |                                                                                                                 |             |                 |             |               |
| Input Voltage                             |                | Refers to driving signal level:<br>Logic low, $I_{sink} \geq 1 \mu A$<br>Logic high, $I_{source} \leq -5 \mu A$ | 4.0         |                 | 0.3         | V             |
| Input Current                             |                |                                                                                                                 |             | -1.0            |             | $\mu A$       |
| <b>EN INPUT</b>                           |                |                                                                                                                 |             |                 |             |               |
| Input Voltage                             |                | Refers to driving signal level:<br>Logic low, $I_{sink} \geq 1 \mu A$<br>Logic high, $I_{source} \leq -5 \mu A$ | 1.6         |                 | 0.3         | V             |
| Input Current                             |                | EN = L or EN = H (Static)<br>0.8 V < EN < 1.6 V (During Transition)                                             |             | 10<br>70        |             | nA<br>$\mu A$ |
| <b>SUPPLY</b>                             |                |                                                                                                                 |             |                 |             |               |
| Supply Voltage Range                      | $V_{CC}$       |                                                                                                                 | 4.5         |                 | 5.5         | V             |
| Supply Current                            |                | EN = H<br>EN = 0 V                                                                                              |             | 5.0<br>60       | 8.0<br>150  | mA<br>$\mu A$ |
| $V_{CC}$ OK Threshold                     | $V_{CCOK}$     | $V_{CC}$ is Rising                                                                                              |             | 4.4             | 4.5         | V             |
| $V_{CC}$ UVLO Threshold                   | $V_{CCUVLO}$   | $V_{CC}$ is Falling                                                                                             | 4.0         | 4.15            |             | V             |
| $V_{CC}$ Hysteresis (Note 2)              |                |                                                                                                                 |             | 250             |             | mV            |

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3. Timing is referenced to the 90% and 10% points, unless otherwise noted.

# ADP3209D

**ELECTRICAL CHARACTERISTICS**  $V_{CC} = 5.0V$ ,  $FBRTN = GND$ ,  $\overline{V_{AFREQ}} = Low$ ,  $V_{VID} = 1.25V$ ,  $T_A = -10^{\circ}C$  to  $100^{\circ}C$ , unless otherwise noted (Note 1). Current entering a pin (sunk by the device) has a positive sign.  $R_{REF} = 80k\Omega$ .

| Parameter | Symbol | Conditions | Min | Typ | Max | Unit |
|-----------|--------|------------|-----|-----|-----|------|
|-----------|--------|------------|-----|-----|-----|------|

## HIGH-SIDE MOSFET DRIVER

|                                      |                                  |                                                                          |  |            |          |          |
|--------------------------------------|----------------------------------|--------------------------------------------------------------------------|--|------------|----------|----------|
| Pullup Resistance, Sourcing Current  |                                  | BST = PVCC                                                               |  | 1.8        | 3.3      | $\Omega$ |
| Pulldown Resistance, Sinking Current |                                  | BST = PVCC                                                               |  | 1.0        | 3.0      | $\Omega$ |
| Transition Times                     | $t_{r_{DRVH}}$<br>$t_{f_{DRVH}}$ | BST = PVCC, $C_L = 3nF$ , Figure 2<br>BST = PVCC, $C_L = 3nF$ , Figure 2 |  | 15<br>13   | 35<br>31 | ns       |
| Dead Delay Times                     | $t_{pd_{DRVH}}$                  | BST = PVCC, Figure 2                                                     |  | 30         | 42       | ns       |
| BST Quiescent Current                |                                  | EN = L (Shutdown)<br>EN = H, no switching                                |  | 2.0<br>200 | 12       | $\mu A$  |

## LOW-SIDE MOSFET DRIVER

|                                      |                                    |                                                  |     |            |          |          |
|--------------------------------------|------------------------------------|--------------------------------------------------|-----|------------|----------|----------|
| Pullup Resistance, Sourcing Current  |                                    | BST = PVCC                                       |     | 1.7        | 3.3      | $\Omega$ |
| Pulldown Resistance, Sinking Current |                                    | BST = PVCC                                       |     | 0.8        | 2.0      | $\Omega$ |
| Transition Times                     | $t_{r_{DRV L}}$<br>$t_{f_{DRV L}}$ | $C_L = 3nF$ , Figure 2<br>$C_L = 3nF$ , Figure 2 |     | 15<br>14   | 35<br>35 | ns       |
| Propagation Delay Times              | $t_{pd_{DRV L}}$                   | $C_L = 3nF$ , Figure 2                           |     | 10         | 30       | ns       |
| SW Transition Timeout                | $t_{TOSW}$                         | DRVH = L, SW = 2.5 V                             | 150 | 250        | 350      | ns       |
| SW Off Threshold                     | $V_{OFFSW}$                        |                                                  |     | 1.6        |          | V        |
| PVCC Quiescent Current               |                                    | EN = L (Shutdown)<br>EN = H, no switching        |     | 5.0<br>240 | 15       | $\mu A$  |

## BOOTSTRAP RECTIFIER SWITCH

|               |  |                                |     |     |     |          |
|---------------|--|--------------------------------|-----|-----|-----|----------|
| On Resistance |  | EN = L or EN = H and DRV L = H | 3.0 | 6.0 | 1.0 | $\Omega$ |
|---------------|--|--------------------------------|-----|-----|-----|----------|

1. All limits at temperature extremes are guaranteed via correlation using standard Statistical Quality Control (SQC).
2. Guaranteed by design or bench characterization, not production tested.
3. Timing is referenced to the 90% and 10% points, unless otherwise noted.

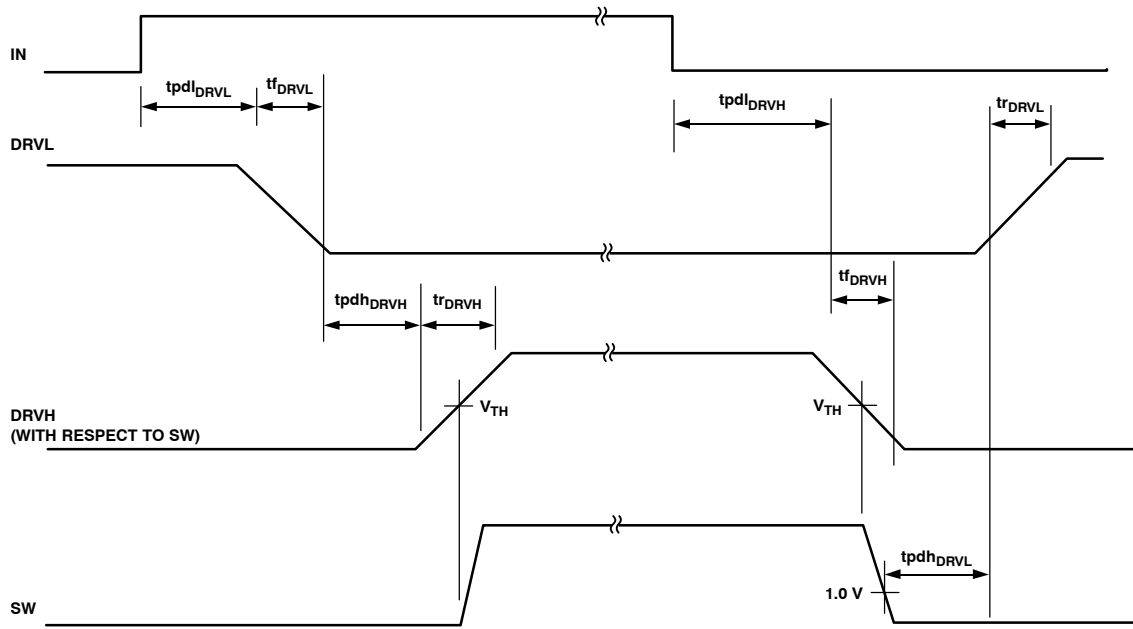


Figure 2. Timing Diagram (Note 3)

TYPICAL PERFORMANCE CHARACTERISTICS

$V_{VID} = 1.5\text{ V}$ ,  $T_A = 20^\circ\text{C}$  to  $100^\circ\text{C}$ , unless otherwise noted.

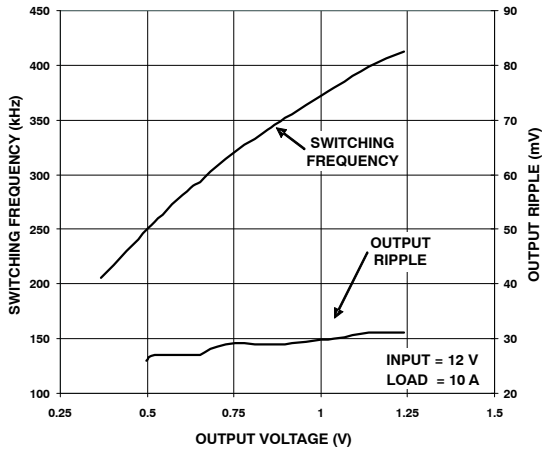


Figure 3. Switching Frequency vs. Load Current in RPM Mode

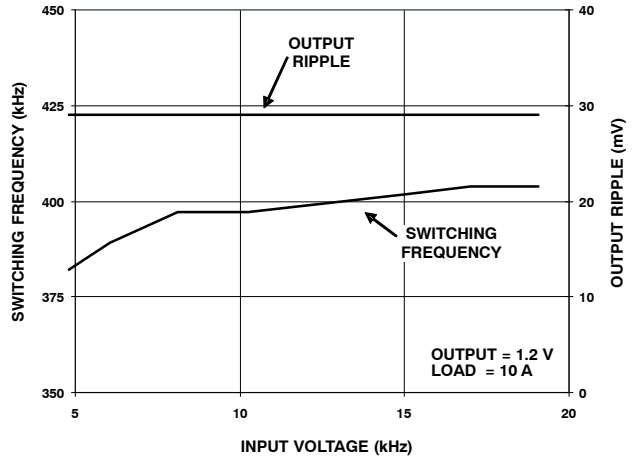


Figure 4. Switching Frequency vs. Input Voltage in RPM Mode

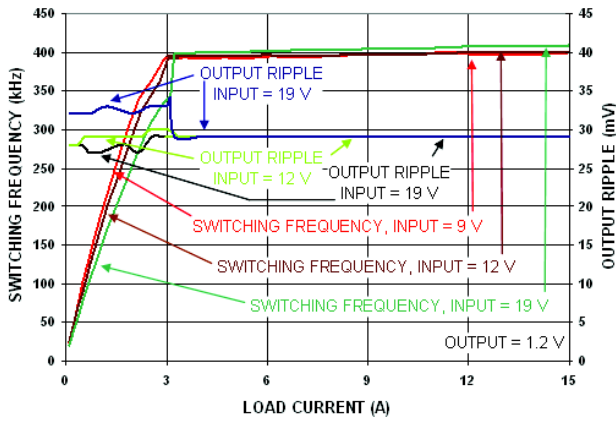


Figure 5. Switching Frequency vs. Input Voltage in RPM Mode

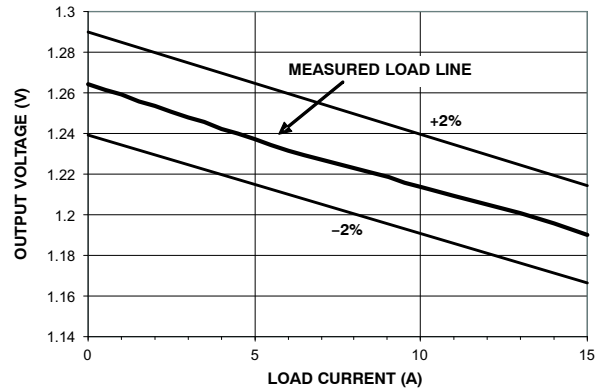


Figure 6. Load Line Accuracy

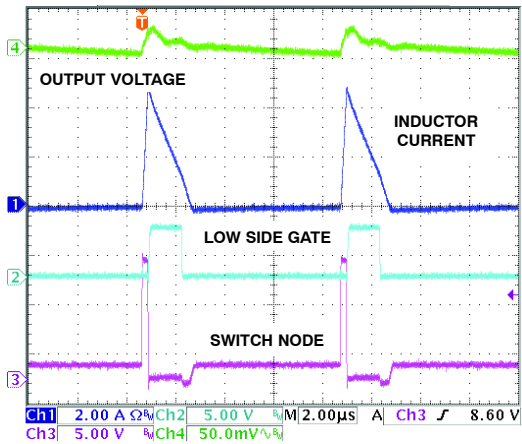


Figure 7. DCM Waveforms, 0.5 A Load Current

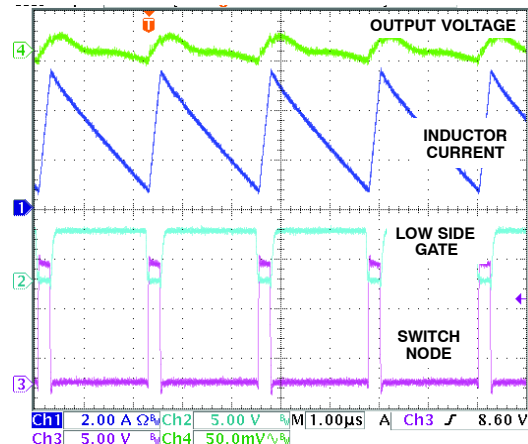


Figure 8. CCM Waveforms, 3 A Load Current



# ADP3209D

## TYPICAL PERFORMANCE CHARACTERISTICS

$V_{VID} = 1.5\text{ V}$ ,  $T_A = 20^\circ\text{C}$  to  $100^\circ\text{C}$ , unless otherwise noted.

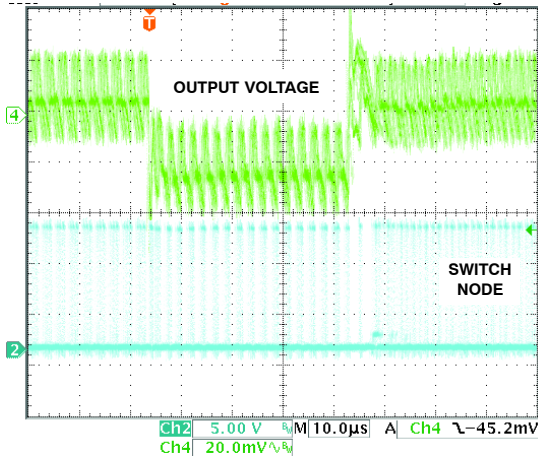


Figure 9. Load Transient, 3 A to 10 A,  $V_{IN} = 12\text{ V}$

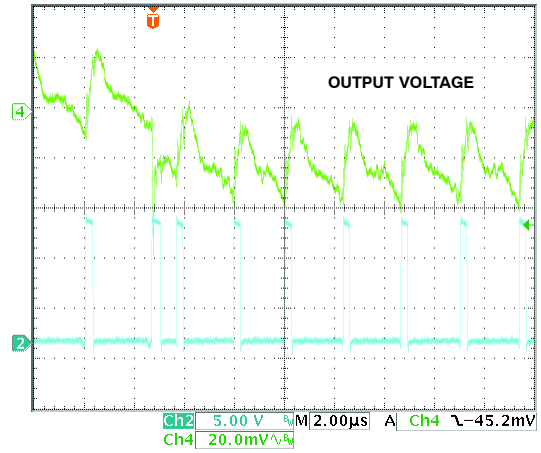


Figure 10. Load Transient, 3 A to 10 A,  $V_{IN} = 12\text{ V}$

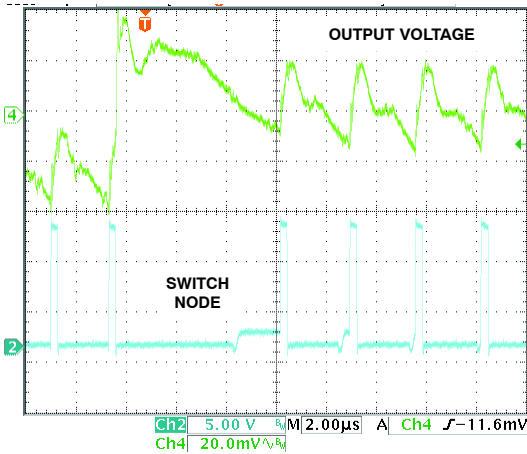


Figure 11. Load Transient, 3 A to 10 A,  $V_{IN} = 12\text{ V}$

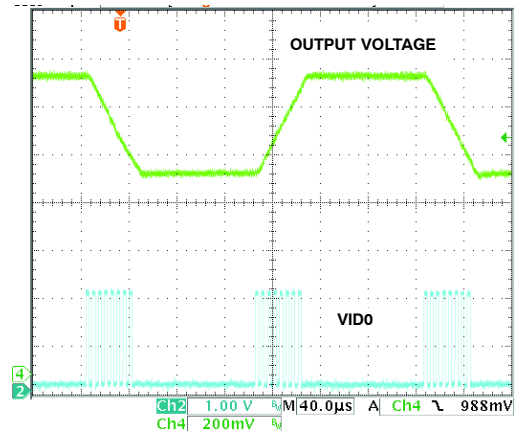


Figure 12. VID OTF, 1.25 V to 0.85 V

# ADP3209D

## Theory of Operation

The ADP3209D is a ramp-pulse-modulated (RPM) controller for synchronous buck Intel GMCH core power supply. The internal 5-bit VID DAC conforms to the Intel IMVP-6+ specifications. The ADP3209D is a stable, high performance architecture that includes

- High speed response at the lowest possible switching frequency and minimal count of output decoupling capacitors
- Minimized thermal switching losses due to lower frequency operation
- High accuracy load line regulation
- High power conversion efficiency with a light load by automatically switching to DCM operation

## Operation Modes

The ADP3209D runs in RPM mode for the purpose of fast transient response and high light load efficiency. During the following transients, the ADP3209D runs in PWM mode:

- Soft-Start
- Soft transient: the period of 100  $\mu$ s following any VID change
- Current overload

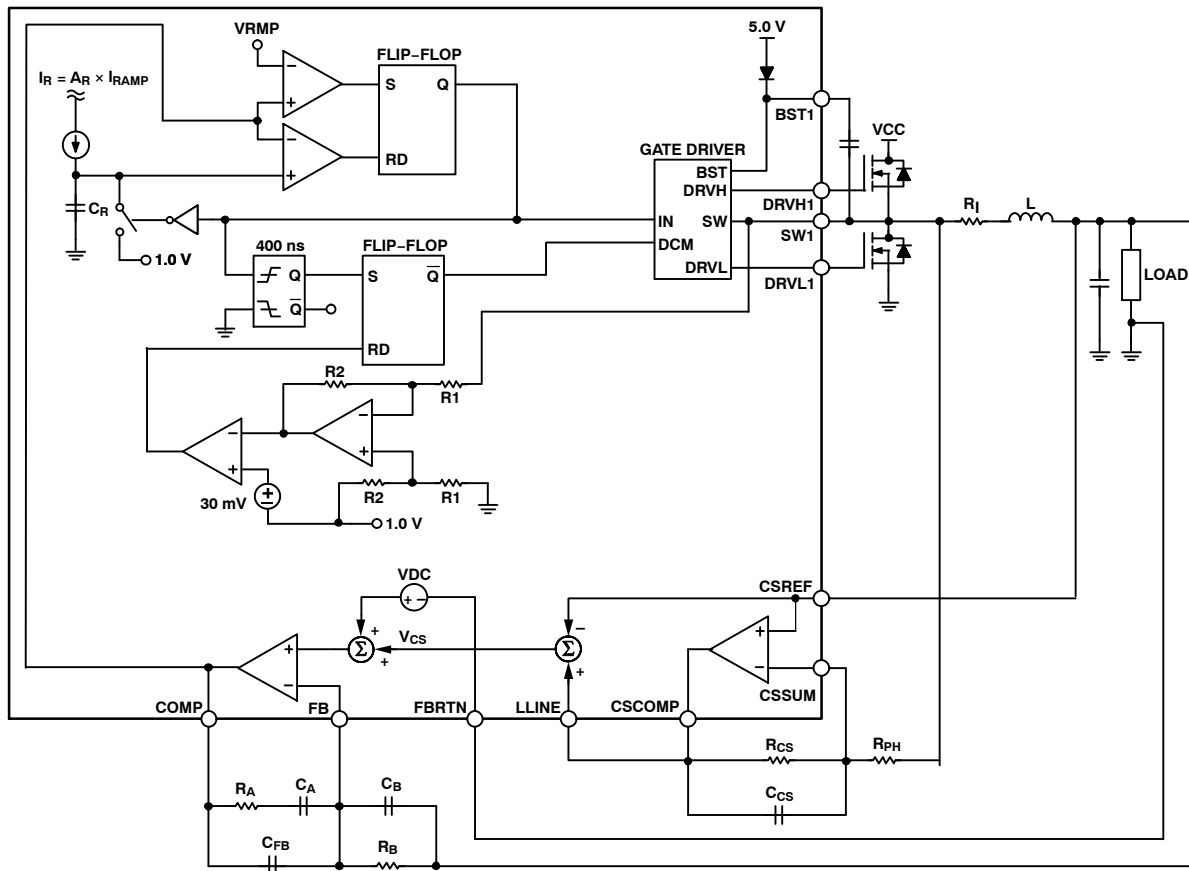


Figure 13. RPM Mode Operation



amplifier can be configured several ways, depending on system optimization objectives, and the current information can be obtained by:

- Output inductor ESR sensing without the use of a thermistor for the lowest cost
- Output inductor ESR sensing with the use of a thermistor that tracks inductor temperature to improve accuracy
- Discrete resistor sensing for the highest accuracy

At the positive input of the CSA, the CSREF pin is connected to the output voltage. At the negative input (that is, the CSFB pin of the CSA), signals from the sensing element (in the case of inductor DCR sensing, signals from the switch node side of the output inductors) are connected with a resistor. The feedback resistor between the CSCOMP and CSFB pins sets the gain of the current sense amplifier, and a filter capacitor is placed in parallel with this resistor. The current information is then given as the voltage difference between the CSCOMP and CSREF pins. This signal is used internally as a differential input for the current limit comparator.

An additional resistor divider connected between the CSCOMP and CSREF pins with the midpoint connected to the LLINE pin can be used to set the load line required by the GMCH specification. The current information to set the load line is then given as the voltage difference between the LLINE and CSREF pins. This configuration allows the load line slope to be set independent from the current limit threshold. If the current limit threshold and load line do not have to be set independently, the resistor divider between the CSCOMP and CSREF pins can be omitted and the CSCOMP pin can be connected directly to LLINE. To disable voltage positioning entirely (that is, to set no load line), LLINE should be tied to CSREF.

To provide the best accuracy for current sensing, the CSA has a low offset input voltage and the sensing gain is set by an external resistor ratio.

#### Active Impedance Control Mode

To control the dynamic output voltage droop as a function of the output current, the signal that is proportional to the total output current, converted from the voltage difference between LLINE and CSREF, can be scaled to be equal to the required droop voltage. This droop voltage is calculated by multiplying the droop impedance of the regulator by the output current. This value is used as the control voltage of the PWM regulator. The droop voltage is subtracted from the DAC reference output voltage, and the resulting voltage is used as the voltage positioning set-point. The arrangement results in an enhanced feed-forward response.

#### Voltage Control Mode

A high-gain bandwidth error amplifier is used for the voltage mode control loop. The non-inverting input voltage is set via the 5-bit VID DAC. The VID codes are listed in Table 1. The non-inverting input voltage is offset by the

droop voltage as a function of current, commonly known as active voltage positioning. The output of the error amplifier is the COMP pin, which sets the termination voltage of the internal PWM ramps.

At the negative input, the FB pin is tied to the output sense location using  $R_B$ , a resistor for sensing and controlling the output voltage at the remote sensing point. The main loop compensation is incorporated in the feedback network connected between the FB and COMP pins.

#### Power-Good Monitoring

The power-good comparator monitors the output voltage via the CSREF pin. The PWRGD pin is an open-drain output that can be pulled up through an external resistor to a voltage rail; not necessarily the same VCC voltage rail that is running the controller. A logic high level indicates that the output voltage is within the voltage limits defined by a range around the VID voltage setting. PWRGD goes low when the output voltage is outside of this range.

Following the GMCH specification, the PWRGD range is defined to be 300 mV less than and 200 mV greater than the actual VID DAC output voltage. To prevent a false alarm, the power-good circuit is masked during any VID change and during soft-start. The duration of the PWRGD mask is set to approximately 100  $\mu$ s by an internal timer.

#### Power-Up Sequence and Soft Start

The power-on ramp-up time of the output voltage is set internally. The ADP3209D steps sequentially through each VID code until it reaches the set VID code voltage. The power-up sequence, including the soft-start is illustrated in Figure 15.

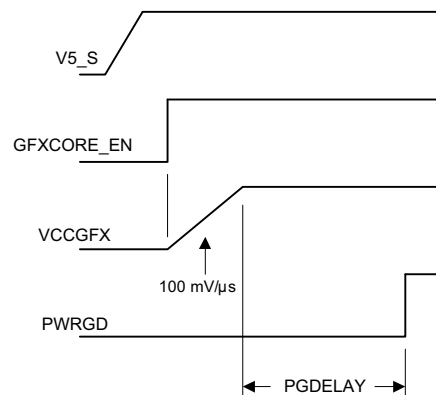


Figure 15. Powerup Sequence of ADP3209D

#### VID Change and Soft Transient

When a VID input changes, the ADP3209D detects the change but ignores new code for a minimum of 400 ns. This delay is required to prevent the device from reacting to digital signal skew while the 5-bit VID input code is in transition. Additionally, the VID change triggers a PWRGD masking timer to prevent a PWRGD failure. Each VID change resets and retriggers the internal PWRGD masking timer.

The ADP3209D provides a soft transient function to reduce inrush current during VID transitions. Reducing the inrush current helps decrease the acoustic noise generated by the MLCC input capacitors and inductors.

The soft transient feature is implemented internally. When a new VID code is detected, the ADP3209D steps sequentially through each VID voltage to the final VID voltage. The ADP3209D steps through VID codes every 0.5  $\mu$ s. This gives a soft transient slew rate of 25 mV per 0.5  $\mu$ s or 12.5 mV/ $\mu$ s. There is a PWRGD masking time of 100 $\mu$ s after the last VID code is changed internally.

**Current Limit, Short-Circuit, and Latchoff Protection**

The ADP3209D has an adjustable current limit set by the R<sub>CLIM</sub> resistor. This resistor is connected from the ILIMN to ILIMP.

Normally, the ADP3209D operates in RPM mode. During a current overload, the ADP3209D switches to PWM mode.

With low impedance loads, the ADP3209D operates in a constant current mode to ensure that the external MOSFETs and inductor function properly and to protect the GPU. With a low constant impedance load, the output voltage decreases to supply only the set current limit. If the output voltage drops below the power-good limit, the PWRGD signal transitions. After the PWRGD single transitions, the ADP3209D will latchoff after 9 ms.

The latchoff function can be reset either by removing and reapplying VCC or by briefly pulling the EN pin low.

During startup, when the output voltage is below 200 mV, a secondary current limit is active. This is necessary because the voltage swing of CSCOMP cannot extend below ground. This secondary current limit clamp controls the minimum internal COMP voltage to the PWM comparators to 1.5 V. This limits the voltage drop across the low-side MOSFETs through the current balance circuitry.

**Light Load RPM DCM Operation**

The ADP3209D operates in RPM mode. With higher loads, the ADP3209D operates in continuous conduction mode (CCM), and the upper and lower MOSFETs run synchronously and in complementary phase. See Figure 16 for the typical waveforms of the ADP3209D running in CCM with a 7 A load current.

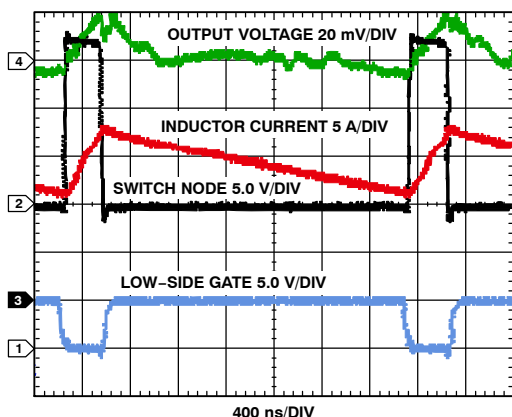


Figure 16. Single-Phase Waveforms in CCM

With lighter loads, the ADP3209D enters discontinuous conduction mode (DCM). Figure NO TAG shows a typical single-phase buck with one upper FET, one lower FET, an output inductor, an output capacitor, and a load resistor. Figure 18 shows the path of the inductor current with the upper FET on and the lower FET off. In Figure 19 the high-side FET is off and the low-side FET is on. In CCM, if one FET is on, its complementary FET must be off; however, in DCM, both high- and low-side FETs are off and no current flows into the inductor (see Figure 20). Figure 21 shows the inductor current and switch node voltage in DCM.

In DCM with a light load, the ADP3209D monitors the switch node voltage to determine when to turn off the low-side FET. Figure 22 shows a typical waveform in DCM with a 1 A load current. Between t<sub>1</sub> and t<sub>2</sub>, the inductor current ramps down. The current flows through the source drain of the low-side FET and creates a voltage drop across the FET with a slightly negative switch node. As the inductor current ramps down to 0 A, the switch voltage approaches 0 V, as seen just before t<sub>2</sub>. When the switch voltage is approximately -6 mV, the low-side FET is turned off.

Figure 21 shows a small, dampened ringing at t<sub>2</sub>. This is caused by the LC created from capacitance on the switch node, including the C<sub>DS</sub> of the FETs and the output inductor. This ringing is normal.

The ADP3209D automatically goes into DCM with a light load. Figure 22 shows the typical DCM waveform of the ADP3209D with a 1 A load current. As the load increases, the ADP3209D enters into CCM. In DCM, frequency decreases with load current, and switching frequency is a function of the inductor, load current, input voltage, and output voltage.

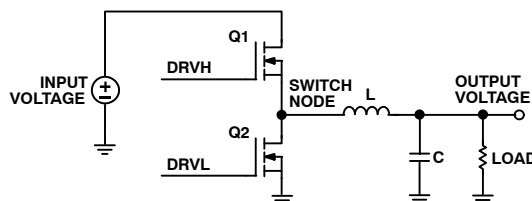


Figure 17. Buck Topology

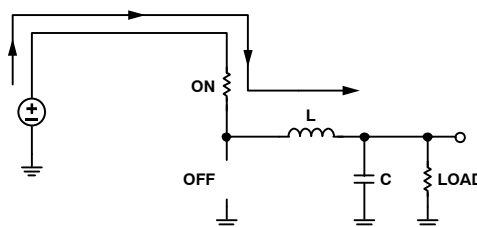


Figure 18. Buck Topology Inductor Current During t<sub>0</sub> and t<sub>1</sub>

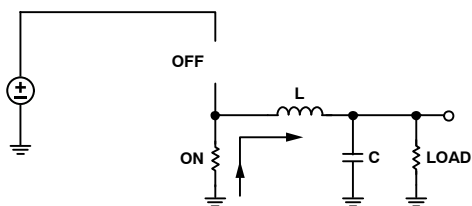


Figure 19. Buck Topology Inductor Current During  $t_1$  and  $t_2$

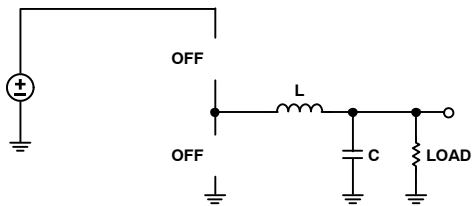


Figure 20. Buck Topology Inductor Current During  $t_2$  and  $t_3$

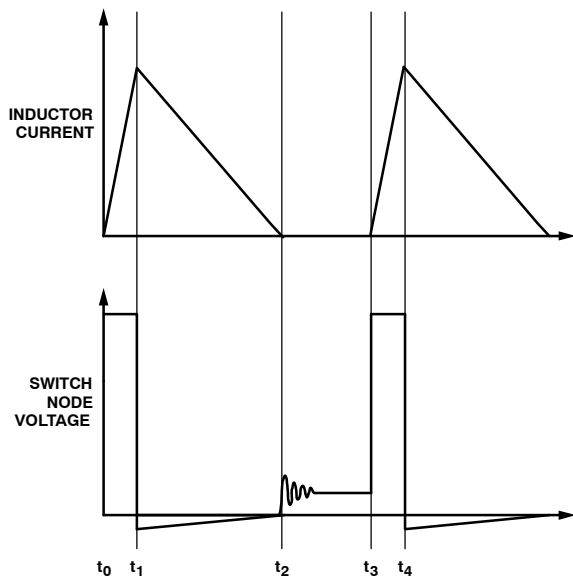


Figure 21. Inductor Current and Switch Node in DCM

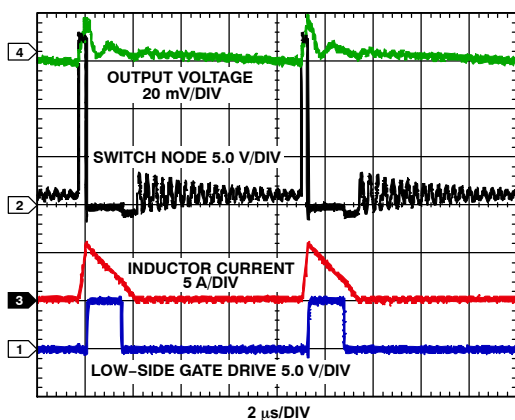


Figure 22. Single-Phase Waveforms in DCM with 1 A Load Current

### Output Crowbar

To protect the load and output components of the supply, the DRVH output is driven high (turning the low-side MOSFETs on) and DRVL is driven low (turning the high-side MOSFETs off) when the output voltage exceeds the GMCH OVP threshold.

Turning on the low-side MOSFETs forces the output capacitor to discharge and the current to reverse due to current build up in the inductors. If the output overvoltage is due to a drain-source short of the high-side MOSFET, turning on the low-side MOSFET results in a crowbar across the input voltage rail. The crowbar action blows the fuse of the input rail, breaking the circuit and thus protecting the GMCH chipset from destruction.

When the OVP feature is triggered, the ADP3209D is latched off. The lathoff function can be reset by removing and reapplying VCC to the ADP3209D or by briefly pulling the EN pin low.

### Reverse Voltage Protection

Very large reverse current in inductors can cause negative  $V_{CCGFX}$  voltage, which is harmful to the chipset and other output components. The ADP3209D provides a reverse voltage protection (RVP) function without additional system cost. The  $V_{CCGFX}$  voltage is monitored through the CSREF pin. When the CSREF pin voltage drops to less than  $-300$  mV, the ADP3209D triggers the RVP function by setting both DRVH and DRVL low, thus turning off all MOSFETs. The reverse inductor currents can be quickly reset to 0 by discharging the built-up energy in the inductor into the input dc voltage source via the forward-biased body diode of the high-side MOSFETs. The RVP function is terminated when the CSREF pin voltage returns to greater than  $-100$  mV.

Sometimes the crowbar feature inadvertently results in negative  $V_{CCGFX}$  voltage because turning on the low-side MOSFETs results in a very large reverse inductor current. To prevent damage to the chipset caused from negative voltage, the ADP3209D maintains its RVP monitoring function even after OVP lathoff. During OVP lathoff, if the CSREF pin voltage drops to less than  $-300$  mV, the low-side MOSFETs is turned off by setting DRVL low. DRVL will be set high again when the CSREF voltage recovers to greater than  $-100$  mV.

Figure 23 shows the reverse voltage protection function of the ADP3209D. The CSREF pin is disconnected from the output voltage and pulled negative. As the CSREF pin drops to less than  $-300$  mV, the low-side and high-side FETs turn off.

## ADP3209D

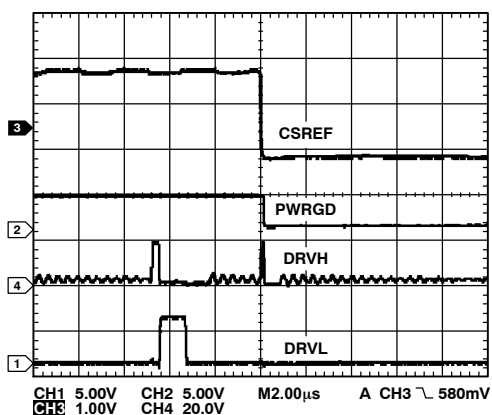


Figure 23. ADP3209D RVP Function

### Output Enable and UVLO

For the ADP3209D to begin switching, the VCC supply voltage to the controller must be greater than the  $V_{CCOK}$  threshold and the EN pin must be driven high. If the VCC

voltage is less than the  $V_{CCUVLO}$  threshold or the EN pin is logic low, the ADP3209D shuts off. In shutdown mode, the controller holds DRVH and DRVL low, shorts the capacitors of the SS and PGDELAY pins to ground, and drives PWRGD to low.

The user must adhere to proper power-supply sequencing during startup and shutdown of the ADP3209D. All input pins must be at ground prior to removing or applying VCC, and all output pins should be left in high impedance state while VCC is off.

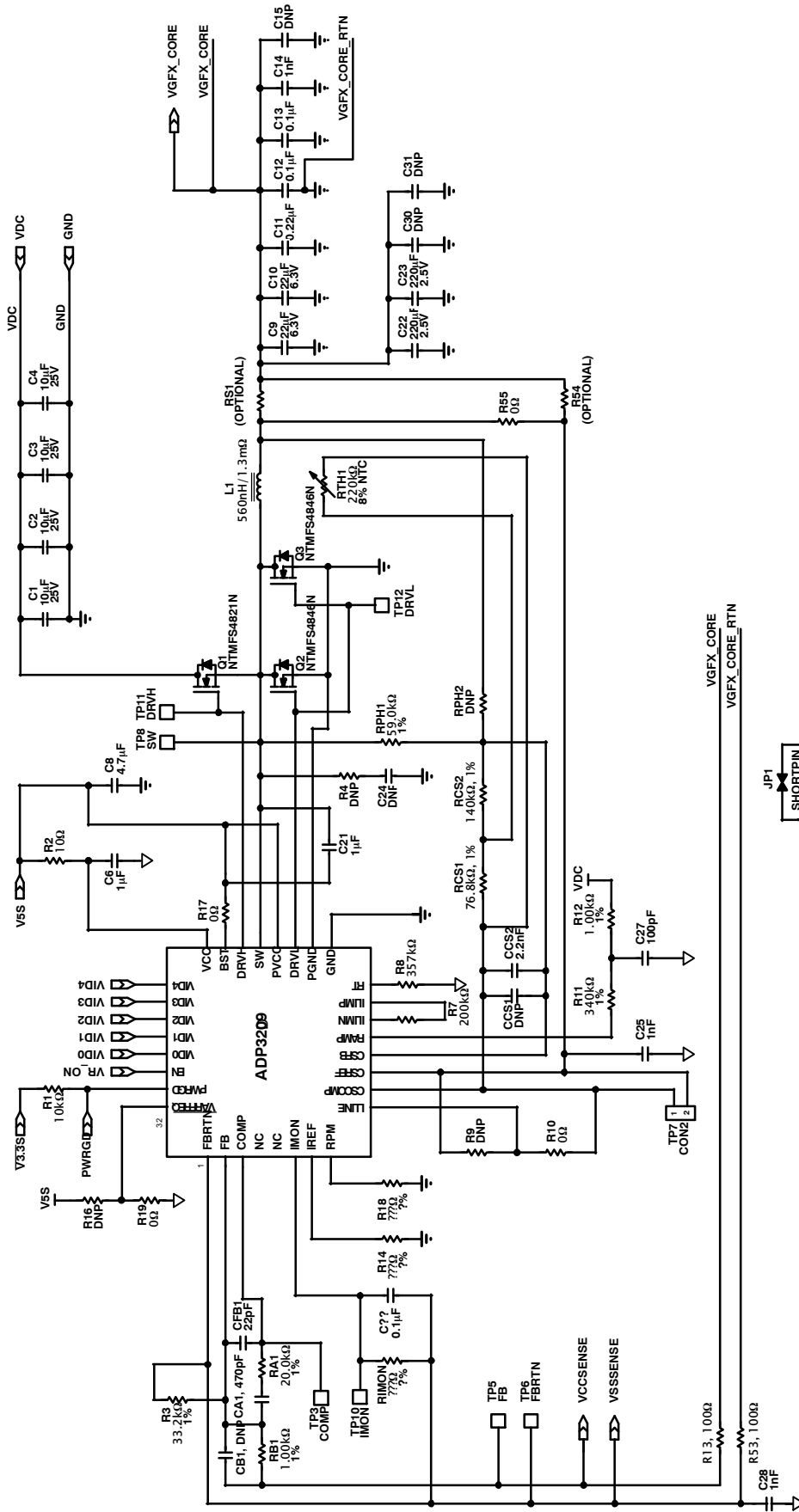
### Current Monitor Function

The ADP3209D has an output current monitor. The IMON pin sources a current proportional to the inductor current. A resistor from IMON pin to FBRTN sets the gain. A 0.1  $\mu$ F is added in parallel with  $R_{MON}$  to filter the inductor ripple. The IMON pin is clamped to prevent it from going above 1.15 V.

Table 1. VID Code Table

| Enable | VID4 | VID3 | VID2 | VID1 | VID0 | Nominal $V_{CCGFX}$ (V) |
|--------|------|------|------|------|------|-------------------------|
| 1      | 0    | 0    | 0    | 0    | 0    | 1.250                   |
| 1      | 0    | 0    | 0    | 0    | 1    | 1.225                   |
| 1      | 0    | 0    | 0    | 1    | 0    | 1.200                   |
| 1      | 0    | 0    | 0    | 1    | 1    | 1.175                   |
| 1      | 0    | 0    | 1    | 0    | 0    | 1.150                   |
| 1      | 0    | 0    | 1    | 0    | 1    | 1.125                   |
| 1      | 0    | 0    | 1    | 1    | 0    | 1.100                   |
| 1      | 0    | 0    | 1    | 1    | 1    | 1.075                   |
| 1      | 0    | 1    | 0    | 0    | 0    | 1.050                   |
| 1      | 0    | 1    | 0    | 0    | 1    | 1.025                   |
| 1      | 0    | 1    | 0    | 1    | 0    | 1.000                   |
| 1      | 0    | 1    | 0    | 1    | 1    | 0.975                   |
| 1      | 0    | 1    | 1    | 0    | 0    | 0.950                   |
| 1      | 0    | 1    | 1    | 0    | 1    | 0.925                   |
| 1      | 0    | 1    | 1    | 1    | 0    | 0.900                   |
| 1      | 0    | 1    | 1    | 1    | 1    | 0.875                   |
| 1      | 1    | 0    | 0    | 0    | 0    | 0.850                   |
| 1      | 1    | 0    | 0    | 0    | 1    | 0.825                   |
| 1      | 1    | 0    | 0    | 1    | 0    | 0.800                   |
| 1      | 1    | 0    | 0    | 1    | 1    | 0.775                   |
| 1      | 1    | 0    | 1    | 0    | 0    | 0.750                   |
| 1      | 1    | 0    | 1    | 0    | 1    | 0.725                   |
| 1      | 1    | 0    | 1    | 1    | 0    | 0.700                   |
| 1      | 1    | 0    | 1    | 1    | 1    | 0.675                   |
| 1      | 1    | 1    | 0    | 0    | 0    | 0.650                   |
| 1      | 1    | 1    | 0    | 0    | 1    | 0.625                   |
| 1      | 1    | 1    | 0    | 1    | 0    | 0.600                   |
| 1      | 1    | 1    | 0    | 1    | 1    | 0.575                   |
| 1      | 1    | 1    | 1    | 0    | 0    | 0.550                   |
| 1      | 1    | 1    | 1    | 0    | 1    | 0.525                   |
| 1      | 1    | 1    | 1    | 1    | 0    | 0.500                   |
| 1      | 1    | 1    | 1    | 1    | 1    | 0.400                   |
| 0      | X    | X    | X    | X    | X    | 0.000                   |

# ADP3209D





**Application Information**

The design parameters for a typical IMVP-6+ compliant GPU core VR application are as follows:

- Maximum input voltage ( $V_{INMAX}$ ) = 19 V
- Minimum input voltage ( $V_{INMIN}$ ) = 8.0 V
- Output voltage by VID setting ( $V_{VID}$ ) = 1.25 V
- Maximum output current ( $I_O$ ) = 15 A
- Droop resistance ( $R_O$ ) = 5.1 mΩ
- Nominal output voltage at 15 A load ( $V_{OFL}$ ) = 1.174 V
- Static output voltage drop from no load to full load ( $\Delta V$ ) =  $V_{ONL} - V_{OFL} = 1.25 V - 1.174 V = 76 mV$
- Maximum output current step ( $\Delta I_O$ ) = 8 A
- Number of phases ( $n$ ) = 1
- Switching frequency ( $f_{SW}$ ) = 390 kHz
- Duty cycle at maximum input voltage ( $D_{MAX}$ ) = 0.15 V
- Duty cycle at minimum input voltage ( $D_{MIN}$ ) = 0.062 V

**Setting the Clock Frequency for PWM**

In PWM operation, the ADP3209D uses a fixed-frequency control architecture. The frequency is set by an external timing resistor ( $R_T$ ). The clock frequency determines the switching frequency, which relates directly to the switching losses and the sizes of the inductors and input and output capacitors. For example, a clock frequency of 300 kHz sets the switching frequency to 300 kHz. This selection represents the trade-off between the switching losses and the minimum sizes of the output filter components. To achieve a 300 kHz oscillator frequency at a VID voltage of 1.2 V,  $R_T$  must be 237 kΩ. Alternatively, the value for  $R_T$  can be calculated by using the following equation:

$$R_T = \frac{V_{VID} + 1.0 V}{2 \times f_{SW} \times 9 pF} - 16 k\Omega \quad (eq. 1)$$

where:

9 pF and 16 kΩ are internal IC component values.

$V_{VID}$  is the VID voltage in volts.

$f_{SW}$  is the switching frequency in hertz.

For good initial accuracy and frequency stability, it is recommended to use a 1% resistor.

With  $\overline{VARFREQ}$  pulled above 4.0 V, the ADP3209D operates with a constant switching frequency. The switching frequency does not change with VID voltage, input voltage, or load current. In addition, the DCM operation at light load is disabled, so the ADP3209D operates in CCM. The value of  $R_T$  can be calculated by using the following equation:

$$R_T = \frac{1.0 V}{f_{SW} \times 9 pF} - 16 k\Omega \quad (eq. 2)$$

**Ramp Resistor Selection**

The ramp resistor ( $R_R$ ) is used for setting the size of the internal PWM ramp. The value of this resistor is chosen to provide the best combination of thermal balance, stability,

and transient response. Use this equation to determine a starting value:

$$R_R = \frac{A_R \times L}{3 \times A_D \times R_{DS} \times C_R} \quad (eq. 3)$$

$$R_R = \frac{0.5 \times 360 nH}{3 \times 5 \times 5.2 m\Omega \times 5 pF} = 462 k\Omega$$

where:

$A_R$  is the internal ramp amplifier gain.

$A_D$  is the current balancing amplifier gain.

$R_{DS}$  is the total low-side MOSFET ON-resistance,

$C_R$  is the internal ramp capacitor value.

Another consideration in the selection of  $R_R$  is the size of the internal ramp voltage (see Equation 3). For stability and noise immunity, keep this ramp size larger than 0.5 V. Taking this into consideration, the value of  $R_R$  is selected as 280 kΩ.

The internal ramp voltage magnitude can be calculated using:

$$V_R = \frac{A_R \times (1 - D) \times V_{VID}}{R_R \times C_R \times f_{SW}} \quad (eq. 4)$$

$$V_R = \frac{0.5 \times (1 - 0.061) \times 1.150 V}{462 k\Omega \times 5 pF \times 280 kHz} = 0.83 V$$

The size of the internal ramp can be made larger or smaller. If it is made larger, then stability and transient response improves, but thermal balance degrades. Likewise, if the ramp is made smaller, then thermal balance improves at the sacrifice of transient response and stability. The factor of three in the denominator of Equation 4 sets a minimum ramp size that gives an optimal balance for good stability, transient response, and thermal balance.

**Setting the Switching Frequency for RPM Operation**

During the RPM operation, the ADP3209D runs in pseudo-constant frequency if the load current is high enough for continuous current mode. While in DCM, the switching frequency is reduced with the load current in a linear manner. To save power with light loads, lower switching frequency is usually preferred during RPM operation. However, the  $V_{CCGFX}$  ripple specification of IMVP-6+ sets a limitation for the lowest switching frequency. Therefore, depending on the inductor and output capacitors, the switching frequency in RPM can be equal to, greater than, or less than its counterpart in PWM.

A resistor from RPM to GND sets the pseudo constant frequency as following:

$$R_{RPM} = \frac{2 \times R_T}{V_{VID} \times 1.0 V} \times \frac{A_R \times (1 - D) \times V_{VID}}{R_R \times C_R \times f_{SW}} - 0.5 k\Omega \quad (eq. 5)$$

where:

$A_R$  is the internal ramp amplifier gain.

$C_R$  is the internal ramp capacitor value.

$R_R$  is an external resistor on the RAMPADJ pin to set the internal ramp magnitude.

Because  $R_R = 280 \text{ k}\Omega$ , the following resistance sets up 300 kHz switching frequency in RPM operation.

$$R_{\text{RPM}} = \frac{2 \times 280 \text{ k}\Omega}{1.150 \text{ V} + 1.0 \text{ V}} \times \frac{0.5 \times (1 - 0.061) \times 1.150}{462 \text{ k}\Omega \times 5 \text{ pF} \times 300 \text{ kHz}} - 500 \text{ k}\Omega = 202 \text{ k}\Omega \quad (\text{eq. 6})$$

### Inductor Selection

The choice of inductance determines the ripple current of the inductor. Less inductance results in more ripple current, which increases the output ripple voltage and the conduction losses in the MOSFETs. However, this allows the use of smaller-size inductors, and for a specified peak-to-peak transient deviation, it allows less total output capacitance. Conversely, a higher inductance results in lower ripple current and reduced conduction losses, but it requires larger-size inductors and more output capacitance for the same peak-to-peak transient deviation. For a buck converter, the practical value for peak-to-peak inductor ripple current is less than 50% of the maximum dc current of that inductor. Equation 7 shows the relationship between the inductance, oscillator frequency, and peak-to-peak ripple current. Equation 8 can be used to determine the minimum inductance based on a given output ripple voltage.

$$I_R = \frac{V_{\text{VID}} \times (1 - D_{\text{MIN}})}{f_{\text{SW}} \times L} \quad (\text{eq. 7})$$

$$L \geq \frac{V_{\text{VID}} \times R_O \times (1 - (n \times D_{\text{MIN}}))}{f_{\text{SW}} \times V_{\text{RIPPLE}}} \quad (\text{eq. 8})$$

In this example,  $R_O$  is assumed to be the ESR of the output capacitance, which results in an optimal transient response. Solving Equation 9 for a 16 mV peak-to-peak output ripple voltage yields:

$$L \geq \frac{1.174 \text{ V} \times 5.1 \text{ m}\Omega \times (1 - 0.062)}{390 \text{ kHz} \times 16 \text{ mV}} = 901 \text{ nH} \quad (\text{eq. 9})$$

If the resultant ripple voltage is less than the initially selected value, the inductor can be changed to a smaller value until the ripple value is met. This iteration allows optimal transient response and minimum output decoupling. In this example, the iteration showed that a 560 nH inductor was sufficient to achieve a good ripple.

The smallest possible inductor should be used to minimize the number of output capacitors. Choosing a 560 nH inductor is a good choice for a starting point, and it provides a calculated ripple current of 6.6 A. The inductor should not saturate at the peak current of 18.3 A, and it should be able to handle the sum of the power dissipation caused by the winding's average current (15 A) plus the ac core loss.

Another important factor in the inductor design is the DCR, which is used for measuring the inductor current. Too large of a DCR causes excessive power losses, whereas too small of a value leads to increased measurement error. For this example, an inductor with a DCR of 1.3 m $\Omega$  is used.

### Selecting a Standard Inductor

After the inductance and DCR are known, select a standard inductor that best meets the overall design goals. It is also important to specify the inductance and DCR tolerance to maintain the accuracy of the system. Using 20% tolerance for the inductance and 15% for the DCR at room temperature are reasonable values that most manufacturers can meet.

### Power Inductor Manufacturers

The following companies provide surface-mount power inductors optimized for high power applications upon request.

- Vishay Dale Electronics, Inc.
- Panasonic
- Sumida Electric Company
- NEC Tokin Corporation

### Output Droop Resistance

The design requires that the regulator output voltage measured at the chipset pins decreases when the output current increases. The specified voltage drop corresponds to the droop resistance ( $R_O$ ).

The output current is measured by low-pass filtering the voltage across the inductor or current sense resistor. The filter is implemented by the CS amplifier that is configured with  $R_{\text{PH}}$ ,  $R_{\text{CS}}$ , and  $C_{\text{CS}}$ . The output resistance of the regulator is set by the following equations:

$$R_O = \frac{R_{\text{CS}}}{R_{\text{PH}(x)}} \times R_{\text{SENSE}} \quad (\text{eq. 10})$$

$$C_{\text{CS}} = \frac{L}{R_{\text{SENSE}} \times R_{\text{CS}}} \quad (\text{eq. 11})$$

where  $R_{\text{SENSE}}$  is the DCR of the output inductors.

Either  $R_{\text{CS}}$  or  $R_{\text{PH}}$  can be chosen for added flexibility. Due to the current drive ability of the CSCOMP pin, the  $R_{\text{CS}}$  resistance should be greater than 100 k $\Omega$ . For example, initially select  $R_{\text{CS}}$  to be equal to 200 k $\Omega$ , and then use Equation 11 to solve for  $C_{\text{CS}}$ :

$$C_{\text{CS}} = \frac{560 \text{ nH}}{1.3 \text{ m}\Omega \times 200 \text{ k}\Omega} = 2.2 \text{ nF} \quad (\text{eq. 12})$$

If  $C_{\text{CS}}$  is not a standard capacitance,  $R_{\text{CS}}$  can be tuned. In this case, the required  $C_{\text{CS}}$  is a standard value and no tuning is required. For best accuracy,  $C_{\text{CS}}$  should be a 5% NPO capacitor.

Next, solve for  $R_{\text{PH}}$  by rearranging Equation 10 as follows:

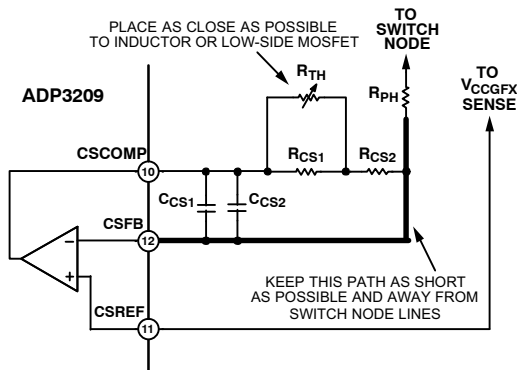
$$R_{\text{PH}} \geq \frac{1.3 \text{ m}\Omega}{5.1 \text{ m}\Omega} \times 200 \text{ k}\Omega = 51.0 \text{ k}\Omega \quad (\text{eq. 13})$$

The standard 1% resistor for  $R_{\text{PH}}$  is 51.1 k $\Omega$ .

### Inductor DCR Temperature Correction

If the DCR of the inductor is used as a sense element and copper wire is the source of the DCR, the temperature changes associated with the inductor's winding must be compensated for. Fortunately, copper has a well-known temperature coefficient (TC) of 0.39%/°C.

If  $R_{CS}$  is designed to have an opposite but equal percentage of change in resistance, it cancels the temperature variation of the inductor's DCR. Due to the nonlinear nature of NTC thermistors, series resistors  $R_{CS1}$  and  $R_{CS2}$  (see Figure 25) are needed to linearize the NTC and produce the desired temperature coefficient tracking.



**Figure 25. Temperature-Compensation Circuit Values**

The following procedure and expressions yield values for  $R_{CS1}$ ,  $R_{CS2}$ , and  $R_{TH}$  (the thermistor value at 25°C) for a given  $R_{CS}$  value.

1. Select an NTC to be used based on its type and value. Because the value needed is not yet determined, start with a thermistor with a value close to  $R_{CS}$  and an NTC with an initial tolerance of better than 5%.
2. Find the relative resistance value of the NTC at two temperatures. The appropriate temperatures will depend on the type of NTC, but 50°C and 90°C have been shown to work well for most types of NTCs. The resistance values are called A ( $A$  is  $R_{TH}(50^\circ\text{C})/R_{TH}(25^\circ\text{C})$ ) and B ( $B$  is  $R_{TH}(90^\circ\text{C})/R_{TH}(25^\circ\text{C})$ ). Note that the relative value of the NTC is always 1 at 25°C.
3. Find the relative value of  $R_{CS}$  required for each of the two temperatures. The relative value of  $R_{CS}$  is based on the percentage of change needed, which is initially assumed to be 0.39%/°C in this example. The relative values are called  $r_1$  ( $r_1$  is  $1/(1 + \text{TC} \times (T_1 - 25))$ ) and  $r_2$  ( $r_2$  is  $1/(1 + \text{TC} \times (T_2 - 25))$ ), where TC is 0.0039,  $T_1$  is 50°C, and  $T_2$  is 90°C.
4. Compute the relative values for  $r_{CS1}$ ,  $r_{CS2}$ , and  $r_{TH}$  by using the following equations:

$$r_{CS2} = \frac{(A - B) \times r_1 \times r_2 - A \times (1 - B) \times r_2 + B \times (1 - A) \times r_1}{A \times (1 - B) \times r_1 - B \times (1 - A) \times r_2 - (A - B)}$$

$$r_{CS1} = \frac{(1 - A)}{\frac{1}{1 - r_{CS2}} - \frac{1}{r_1 - r_{CS2}}}$$

$$r_{TH} = \frac{1}{\frac{1}{1 - r_{CS2}} - \frac{1}{r_{CS1}}} \quad (\text{eq. 14})$$

5. Calculate  $R_{TH} = r_{TH} \times R_{CS}$ , and then select a thermistor of the closest value available. In addition, compute a scaling factor  $k$  based on the ratio of the actual thermistor value used relative to the computed one:

$$k = \frac{R_{TH(\text{ACTUAL})}}{R_{TH(\text{CALCULATED})}} \quad (\text{eq. 15})$$

6. Calculate values for  $R_{CS1}$  and  $R_{CS2}$  by using the following equations:

$$\begin{aligned} R_{CS1} &= R_{CS} \times k \times r_{CS1} \\ R_{CS2} &= R_{CS} \times ((1 - k) + (k \times r_{CS2})) \end{aligned} \quad (\text{eq. 16})$$

For example, if a thermistor value of 100 k $\Omega$  is selected in Step 1, an available 0603-size thermistor with a value close to  $R_{CS}$  is the Vishay NTHS0603N04 NTC thermistor, which has resistance values of  $A = 0.3359$  and  $B = 0.0771$ . Using the equations in Step 4,  $r_{CS1}$  is 0.359,  $r_{CS2}$  is 0.729, and  $r_{TH}$  is 1.094. Solving for  $r_{TH}$  yields 219 k $\Omega$ , so a thermistor of 220 k $\Omega$  would be a reasonable selection, making  $k$  equal to 1.005. Finally,  $R_{CS1}$  and  $R_{CS2}$  are found to be 72.2 k $\Omega$  and 146 k $\Omega$ . Choosing the closest 1% resistor values yields a choice of 71.5 k $\Omega$  and 147 k $\Omega$ .

### C<sub>OUT</sub> Selection

The required output decoupling for processors and platforms is typically recommended by Intel. For systems containing both bulk and ceramic capacitors, however, the following guidelines can be a helpful supplement.

Select the number of ceramics and determine the total ceramic capacitance ( $C_Z$ ). This is based on the number and type of capacitors used. Keep in mind that the best location to place ceramic capacitors is inside the socket; however, the physical limit is twenty 0805-size pieces inside the socket. Additional ceramic capacitors can be placed along the outer edge of the socket. A combined ceramic capacitor value of 40  $\mu\text{F}$  to 50  $\mu\text{F}$  is recommended and is usually composed of multiple 10  $\mu\text{F}$  or 22  $\mu\text{F}$  capacitors.

Ensure that the total amount of bulk capacitance ( $C_X$ ) is within its limits. The upper limit is dependent on the VID OTF output voltage stepping (voltage step,  $V_V$ , in time,  $t_V$ , with error of  $V_{ERR}$ ); the lower limit is based on meeting the critical capacitance for load release at a given maximum load step,  $\Delta I_O$ . The current version of the IMVP-6+ specification allows a maximum  $V_{CCGFX}$  overshoot ( $V_{OSMAX}$ ) of 10 mV more than the VID voltage for a step-off load current.

$$C_{X(MIN)} \geq \left[ \frac{L \times \Delta I_O}{\left( R_O + \frac{V_{OSMAX}}{\Delta I_O} \right) \times V_{VID}} - C_Z \right] \quad (\text{eq. 17})$$

$$C_{X(MAX)} \leq \frac{L}{k^2 \times R_O^2} \times \frac{V_V}{V_{VID}} \times \left[ \sqrt{1 + \left( t_v \frac{V_{VID}}{V_V} \times \frac{k \times R_O}{L} \right)^2} - 1 \right] - C_Z$$

where:

$$k = -1n \left( \frac{V_{ERR}}{V_V} \right) \quad (\text{eq. 18})$$

To meet the conditions of these expressions and the transient response, the ESR of the bulk capacitor bank ( $R_X$ ) should be less than two times the droop resistance,  $R_O$ . If the  $C_{X(MIN)}$  is greater than  $C_{X(MAX)}$ , the system does not meet the VID OTF specifications and may require less inductance. In addition, the switching frequency may have to be increased to maintain the output ripple.

For example, if two pieces of 22  $\mu\text{F}$ , 0805-size MLC capacitors ( $C_Z = 44 \mu\text{F}$ ) are used during a VID voltage change, the  $V_{CCGFX}$  change is 220 mV in 22  $\mu\text{s}$  with a setting error of 10 mV. If  $k = 3.1$ , solving for the bulk capacitance yields:

$$C_{X(MIN)} \geq \left[ \frac{560 \text{ nH} \times 8 \text{ A}}{\left( 5.1 \text{ m}\Omega + \frac{10 \text{ mV}}{8 \text{ A}} \right) \times 1.174 \text{ V}} - 44 \mu\text{F} \right] = 256 \mu\text{F}$$

$$C_{X(MAX)} \leq \frac{560 \text{ nH} \times 220 \text{ mV}}{3.1^2 \times (5.1 \text{ m}\Omega)^2 \times 1.174 \text{ V}} \times \left[ \sqrt{1 + \left( \frac{22 \mu\text{s} \times 1.174 \text{ V} \times 3.1 \times 5.1 \text{ m}\Omega}{220 \text{ mV} \times 560 \text{ nH}} \right)^2} - 1 \right] = 992 \mu\text{F}$$

Using two 220  $\mu\text{F}$  Panasonic SP capacitors with a typical ESR of 7 m $\Omega$  each yields  $C_X = 440 \mu\text{F}$  and  $R_X = 3.5 \text{ m}\Omega$ .

Ensure that the ESL of the bulk capacitors ( $L_X$ ) is low enough to limit the high frequency ringing during a load change. This is tested using:

$$L_X \leq C_Z \times R_O^2 \times Q^2$$

$$L_X \leq 44 \mu\text{F} \times (5.1 \text{ m}\Omega)^2 \times 2 = 2.3 \text{ nH} \quad (\text{eq. 19})$$

where:

$Q$  is limited to the square root of 2 to ensure a critically damped system.

$L_X$  is about 450 pH for the two SP capacitors, which is low enough to avoid ringing during a load change. If the  $L_X$  of the chosen bulk capacitor bank is too large, the number of ceramic capacitors may need to be increased to prevent excessive ringing.

For this multi-mode control technique, an all ceramic capacitor design can be used if the conditions of Equations 17, 18, and 19 are satisfied.

### Power MOSFETs

For typical 15 A per phase applications, the N-channel power MOSFETs are selected for one high-side switch and one low-side switch. The main selection parameters for the power MOSFETs are  $V_{GS(TH)}$ ,  $Q_G$ ,  $C_{ISS}$ ,  $C_{RSS}$ , and  $R_{DS(ON)}$ . Because the voltage of the gate driver is 5.0 V, logic-level threshold MOSFETs must be used.

The maximum output current,  $I_O$ , determines the  $R_{DS(ON)}$  requirement for the low-side (synchronous) MOSFETs. With conduction losses being dominant, the following expression shows the total power that is dissipated in each synchronous MOSFET in terms of the ripple current per phase ( $I_R$ ) and the average total output current ( $I_O$ ):

$$P_{SF} = (1 - D) \times \left[ \left( \frac{I_O}{n_{SF}} \right)^2 + \frac{1}{12} \times \left( \frac{I_R}{n_{SF}} \right)^2 \right] \times R_{DS(SF)} \quad (\text{eq. 20})$$

where:

$D$  is the duty cycle and is approximately the output voltage divided by the input voltage.

$I_R$  is the inductor peak-to-peak ripple current and is approximately:

$$I_R = \frac{(1 - D) \times V_{OUT}}{L \times f_{SW}} \quad (\text{eq. 21})$$

Knowing the maximum output current and the maximum allowed power dissipation, the user can calculate the required  $R_{DS(ON)}$  for the MOSFET. For an 8-lead SOIC or 8-lead SOIC-compatible MOSFET, the junction-to-ambient (PCB) thermal impedance is 50°C/W. In the worst case, the PCB temperature is 70°C to 80°C during heavy load operation of the notebook, and a safe limit for  $P_{SF}$  is about 0.8 W to 1.0 W at 120°C junction temperature. Therefore, for this example (15 A maximum), the  $R_{DS(SF)}$  per MOSFET is less than 18.8 m $\Omega$  for the low-side MOSFET. This  $R_{DS(SF)}$  is also at a junction temperature of about 120°C; therefore, the  $R_{DS(SF)}$  per MOSFET should be less than 13.3 m $\Omega$  at room temperature, or 18.8 m $\Omega$  at high temperature.

Another important factor for the synchronous MOSFET is the input capacitance and feedback capacitance. The ratio of the feedback to input must be small (less than 10% is recommended) to prevent accidentally turning on the synchronous MOSFETs when the switch node goes high.

The high-side (main) MOSFET must be able to handle two main power dissipation components: conduction losses and switching losses. Switching loss is related to the time for the main MOSFET to turn on and off and to the current and voltage that are being switched. Basing the switching speed on the rise and fall times of the gate driver impedance and MOSFET input capacitance, the following expression

provides an approximate value for the switching loss per main MOSFET:

$$P_{S(MF)} = 2 \times f_{SW} \times \frac{V_{DC} \times I_O}{n_{MF}} \times R_G \times n_{MF} \times C_{ISS} \quad (\text{eq. 22})$$

where:

$n_{MF}$  is the total number of main MOSFETs.

$R_G$  is the total gate resistance.

$C_{ISS}$  is the input capacitance of the main MOSFET.

The most effective way to reduce switching loss is to use lower gate capacitance devices.

The conduction loss of the main MOSFET is given by the following equation:

$$P_{C(MF)} = D \times \left[ \left( \frac{I_O}{n_{MF}} \right)^2 + \frac{1}{12} \times \left( \frac{I_R}{n_{MF}} \right)^2 \right] \times R_{DS(MF)} \quad (\text{eq. 23})$$

where  $R_{DS(MF)}$  is the on resistance of the MOSFET.

Typically, a user wants the highest speed (low  $C_{ISS}$ ) device for a main MOSFET, but such a device usually has higher on resistance. Therefore, the user must select a device that meets the total power dissipation (about 0.8 W to 1.0 W for an 8-lead SOIC) when combining the switching and conduction losses.

For example, an IRF7821 device can be selected as the main MOSFET (one in total; that is,  $n_{MF} = 1$ ), with approximately  $C_{ISS} = 1010$  pF (maximum) and  $R_{DS(MF)} = 18$  m $\Omega$  (maximum at  $T_J = 120^\circ\text{C}$ ), and an IR7832 device can be selected as the synchronous MOSFET (two in total; that is,  $n_{SF} = 2$ ), with  $R_{DS(SF)} = 6.7$  m $\Omega$  (maximum at  $T_J = 120^\circ\text{C}$ ). Solving for the power dissipation per MOSFET at  $I_O = 15$  A and  $I_R = 5.0$  A yields 178 mW for each synchronous MOSFET and 446 mW for each main MOSFET. A third synchronous MOSFET is an option to further increase the conversion efficiency and reduce thermal stress.

Finally, consider the power dissipation in the driver. This is best described in terms of the  $Q_G$  for the MOSFETs and is given by the following equation:

$$P_{DRV} = \left[ \frac{f_{SW}}{2 \times n} \times (n_{MF} \times Q_{GMF} + n_{SF} \times Q_{GSF}) + I_{CC} \right] \times V_{CC} \quad (\text{eq. 24})$$

where  $Q_{GMF}$  is the total gate charge for each main MOSFET, and  $Q_{GSF}$  is the total gate charge for each synchronous MOSFET.

The previous equation also shows the standby dissipation ( $I_{CC}$  times the  $V_{CC}$ ) of the driver.

### Ramp Resistor Selection

The ramp resistor ( $R_R$ ) is used to set the size of the internal PWM ramp. The value of this resistor is chosen to provide the best combination of stability and transient response. Use the following expression to determine a starting value:

$$R_R = \frac{A_R \times L}{3 \times A_D \times R_{DS} \times C_R} \quad (\text{eq. 25})$$

$$R_R = \frac{0.2 \times 560 \text{ nH}}{3 \times 5 \times 3.4 \text{ m}\Omega \times 5 \text{ pF}} = 439 \text{ k}\Omega$$

where:

$A_R$  is the internal ramp amplifier gain.

$A_D$  is the current balancing amplifier gain.

$R_{DS}$  is the total low-side MOSFET on resistance.

$C_R$  is the internal ramp capacitor value.

Another consideration in the selection of  $R_R$  is the size of the internal ramp voltage (see Equation 26). For stability and noise immunity, keep the ramp size larger than 0.5 V. Taking this into consideration, the value of  $R_R$  in this example is selected as 340 k $\Omega$ .

The internal ramp voltage magnitude can be calculated as follows:

$$V_R = \frac{A_R \times (1 - D) \times V_{VID}}{R_R \times C_R \times f_{SW}} \quad (\text{eq. 26})$$

$$V_R = \frac{0.2 \times (1 - 0.062) \times 1.174 \text{ V}}{340 \text{ k}\Omega \times 5 \text{ pF} \times 390 \text{ kHz}} = 0.33 \text{ V}$$

The size of the internal ramp can be increased or decreased. If it is increased, stability and transient response improves but thermal balance degrades. Conversely, if the ramp size is decreased, thermal balance improves but stability and transient response degrade. In the denominator of Equation 25, the factor of 3 sets the minimum ramp size that produces an optimal balance of good stability and transient response.

### COMP Pin Ramp

In addition to the internal ramp, there is a ramp signal on the COMP pin due to the droop voltage and output voltage ramps. This ramp amplitude adds to the internal ramp to produce the following overall ramp signal at the PWM input:

$$V_{RT} = \frac{V_R}{\left( 1 - \frac{2 \times (1 - D)}{f_{SW} \times C_X \times R_O} \right)} \quad (\text{eq. 27})$$

where  $C_X$  is the total bulk capacitance, and  $R_O$  is the droop resistance of the regulator. For this example, the overall ramp signal is 0.23 V.

### Current Limit Setpoint

To select the current limit setpoint, we need to find the resistor value for  $R_{LIM}$ . The current limit threshold for the ADP3209D is set when the current in  $R_{LIM}$  is equal to the internal reference current of 20  $\mu\text{A}$ . The current in  $R_{LIM}$  is equal to the inductor current times  $R_O$ .  $R_{LIM}$  can be found using the following equation:

$$R_{LIM} = \frac{I_{LIM} \times R_O}{20 \mu\text{A}} \quad (\text{eq. 28})$$

where:

$R_{LIM}$  is the current limit resistor.  $R_{LIM}$  is connected from the ILIM pin to ground.

$R_O$  is the output load line resistance.

$I_{LIM}$  is the current limit set point. This is the peak inductor current that will trip current limit.

**Current Monitor**

The ADP3209D has output current monitor. The IMON pin sources a current proportional to the total inductor current. A resistor,  $R_{MON}$ , from IMON to FBRTN sets the gain of the output current monitor. A 0.1  $\mu$ F is placed in parallel with  $R_{MON}$  to filter the inductor current ripple and high frequency load transients. Since the IMON pin is connected directly to the CPU, it is clamped to prevent it from going above 1.15V.

The IMON pin current is equal to the  $R_{LIM}$  times a fixed gain of 10.  $R_{MON}$  can be found using the following equation:

$$R_{MON} = \frac{1.15 \text{ V} \times R_{LIM}}{10 \times R_O \times I_{FS}} \quad (\text{eq. 29})$$

where:

$R_{MON}$  is the current monitor resistor.  $R_{MON}$  is connected from IMON pin to FBRTN.

$R_{LIM}$  is the current limit resistor.

$R_O$  is the output load line resistance.

$I_{FS}$  is the output current when the voltage on IMON is at full scale.

**Feedback Loop Compensation Design**

Optimized compensation of the ADP3209D allows the best possible response of the regulator’s output to a load change. The basis for determining the optimum compensation is to make the regulator and output decoupling appear as an output impedance that is entirely resistive over the widest possible frequency range, including dc, and that is equal to the droop resistance ( $R_O$ ). With the resistive output impedance, the output voltage droops in proportion with the load current at any load current slew rate, ensuring the optimal position and allowing the minimization of the output decoupling.

With the multi-mode feedback structure of the ADP3209D, it is necessary to set the feedback compensation so that the converter’s output impedance works in parallel with the output decoupling. In addition, it is necessary to compensate for the several poles and zeros created by the output inductor and decoupling capacitors (output filter).

A Type III compensator on the voltage feedback is adequate for proper compensation of the output filter. Figure 26 shows the Type III amplifier used in the ADP3209D. Figure 27 shows the locations of the two poles and two zeros created by this amplifier.

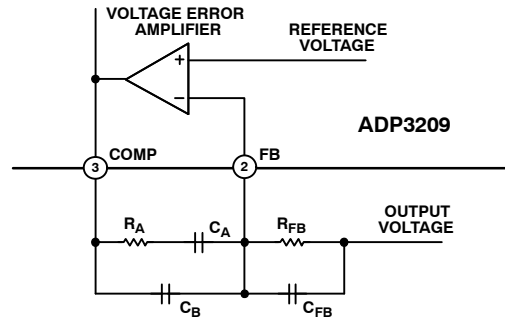


Figure 26. Voltage Error Amplifier

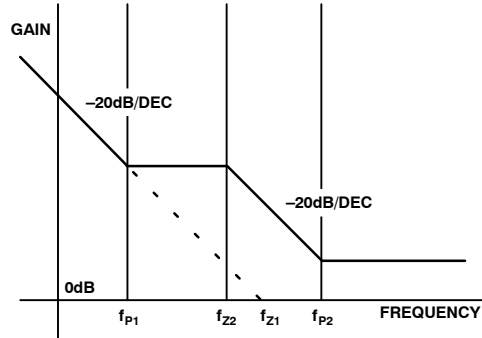


Figure 27. Poles and Zeros of Voltage Error Amplifier

The following equations give the locations of the poles and zeros shown in Figure 27:

$$f_{Z1} = \frac{1}{2\pi \times C_A \times R_A} \quad (\text{eq. 30})$$

$$f_{Z2} = \frac{1}{2\pi \times C_{FB} \times R_{FB}} \quad (\text{eq. 31})$$

$$f_{P1} = \frac{1}{2\pi(C_A + C_B) \times R_{FB}} \quad (\text{eq. 32})$$

$$f_{P2} = \frac{C_A + C_B}{2\pi \times R_A \times C_B + C_A} \quad (\text{eq. 33})$$

The expressions that follow compute the time constants for the poles and zeros in the system and are intended to yield an optimal starting point for the design; some adjustments may be necessary to account for PCB and component parasitic effects (see the Tuning Procedure for ADP3209D section):

$$R_E = R_O + A_D \times R_{DS} + \frac{R_L \times V_{RT}}{V_{ID}} + \frac{2 \times L \times (1 - (n \times D)) \times V_{RT}}{C_X \times R_O \times V_{VID}} \quad (\text{eq. 34})$$

$$T_A = C_X \times (R_O - R') + \frac{L_X}{R_O} \times \frac{R_O - R'}{R_X} \quad (\text{eq. 35})$$

$$T_B = (R_X + R' - R_O) \times C_X \quad (\text{eq. 36})$$

$$T_C = \frac{V_{RT} \times \left( L - \frac{A_D \times R_{DS}}{2 \times f_{SW}} \right)}{V_{VID} \times R_E} \quad (\text{eq. 37})$$

$$T_D = \frac{C_X \times C_Z \times R_O^2}{C_X \times (R_O - R') + C_Z \times R_O} \quad (\text{eq. 38})$$

where:

$R'$  is the PCB resistance from the bulk capacitors to the ceramics and is approximately 0.4 m $\Omega$  (assuming an 8-layer motherboard).

$R_{DS}$  is the total low-side MOSFET on resistance.

$A_D$  is 5.

$V_{RT}$  is 1.25 V.

$L_X$  is the ESL of the bulk capacitors (450 pH for the two Panasonic SP capacitors).

The compensation values can be calculated as follows:

$$C_A = \frac{R_O \times T_A}{R_E \times R_B} \quad (\text{eq. 39})$$

$$R_A = \frac{T_C}{C_A} \quad (\text{eq. 40})$$

$$C_B = \frac{T_B}{R_B} \quad (\text{eq. 41})$$

$$C_{FB} = \frac{T_D}{R_A} \quad (\text{eq. 42})$$

The standard values for these components are subject to the tuning procedure described in the Tuning Procedure for ADP3209D section.

### C<sub>IN</sub> Selection and Input Current di/dt Reduction

In continuous inductor-current mode, the source current of the high-side MOSFET is approximately a square wave with a duty ratio equal to  $V_{OUT}/V_{IN}$ . To prevent large voltage transients, use a low ESR input capacitor sized for the maximum rms current. The maximum rms capacitor current occurs at the lowest input voltage and is given by:

$$I_{CRMS} = D \times I_O \times \sqrt{\frac{1}{D} - 1} \quad (\text{eq. 43})$$

$$I_{CRMS} = 0.15 \times 15 \text{ A} \times \sqrt{\frac{1}{0.15} - 1} = 5.36 \text{ A}$$

where  $I_O$  is the output current.

In a typical notebook system, the battery rail decoupling is achieved by using MLC capacitors or a mixture of MLC capacitors and bulk capacitors. In this example, the input capacitor bank is formed by four pieces of 10  $\mu\text{F}$ , 25 V MLC capacitors, with a ripple current rating of about 1.5 A each.

### Soft Transient Setting

As described in the Theory of Operation section, during the soft transient, the slew rate of the  $V_{CCGF\bar{X}}$  reference voltage change is controlled by the ST pin capacitance. The ST pin capacitance is set to satisfy the slew rate for a fast exit as follows:

$$C_{ST} = \frac{7\mu\text{A}}{\text{SLEWRATE}} \quad (\text{eq. 44})$$

where:

7.5  $\mu\text{A}$  is the source/sink current of the ST pin. Slew Rate is the voltage slew rate after a change in VID voltage and is defined as 10 mV/ $\mu\text{A}$  in the IMVP-6+ specification.  $C_{ST}$  is 750 pF, and the closest standard capacitance is 680 pF.

### Tuning Procedure for ADP3209D

#### Set-Up and Test the Circuit

1. Build a circuit based on the compensation values computed from the design spreadsheet.
2. Connect a dc load to the circuit.
3. Turn on the ADP3209D and verify that it operates properly.
4. Check for jitter with no load and full load conditions.

#### Set the DC Load Line

1. Measure the output voltage with no load ( $V_{NL}$ ) and verify that this voltage is within the specified tolerance range.
2. Measure the output voltage with a full load when the device is cold ( $V_{FLCOLD}$ ). Allow the board to run for ~10 minutes with a full load and then measure the output when the device is hot ( $V_{FLHOT}$ ). If the difference between the two measured voltages is more than a few millivolts, adjust  $R_{CS2}$  using Equation 45.

$$R_{CS2(\text{NEW})} = R_{CS2(\text{OLD})} \times \frac{V_{NL} - V_{FLCOLD}}{V_{NL} - V_{FLHOT}} \quad (\text{eq. 45})$$

3. Repeat Step 2 until no adjustment of  $R_{CS2}$  is needed.
4. Compare the output voltage with no load to that with a full load using 5 A steps. Compute the load line slope for each change and then find the average to determine the overall load line slope ( $R_{OMEAS}$ ).
5. If the difference between  $R_{OMEAS}$  and  $R_O$  is more than 0.05 m $\Omega$ , use the following equation to adjust the  $R_{PH}$  values:

$$R_{PH(\text{NEW})} = R_{PH(\text{OLD})} \times \frac{R_{OMEAS}}{R_O} \quad (\text{eq. 46})$$

6. Repeat Steps 4 and 5 until no adjustment of  $R_{PH}$  is needed. Once this is achieved, do not change  $R_{PH}$ ,  $R_{CS1}$ ,  $R_{CS2}$ , or  $R_{TH}$  for the rest of the procedure.

7. Measure the output ripple with no load and with a full load with scope, making sure both are within the specifications.

#### Set the AC Load Line

1. Remove the dc load from the circuit and connect a dynamic load.
2. Connect the scope to the output voltage and set it to dc coupling mode with a time scale of 100  $\mu\text{s}/\text{div}$ .
3. Set the dynamic load for a transient step of about 40 A at 1 kHz with 50% duty cycle.
4. Measure the output waveform (note that use of a dc offset on the scope may be necessary to see the waveform). Try to use a vertical scale of 100 mV/div or finer.
5. The resulting waveform will be similar to that shown in Figure 28. Use the horizontal cursors to measure  $V_{\text{ACDRP}}$  and  $V_{\text{DCDRP}}$ , as shown in Figure 28. Do not measure the undershoot or overshoot that occurs immediately after the step.

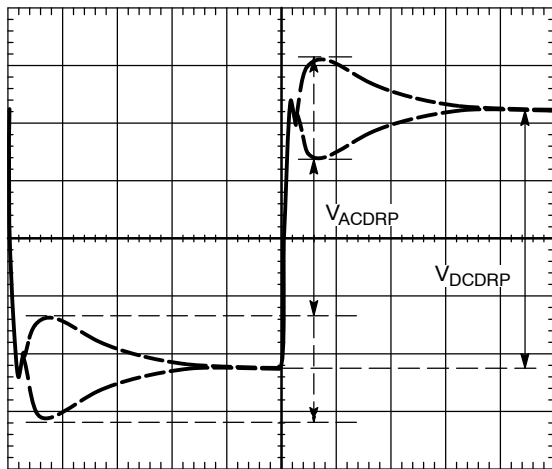


Figure 28. AC Load Line Waveform

6. If the difference between  $V_{\text{ACDRP}}$  and  $V_{\text{DCDRP}}$  is more than a couple of millivolts, use Equation 47 to adjust  $C_{\text{CS}}$ . It may be necessary to try several parallel values to obtain an adequate one because there are limited standard capacitor values available (it is a good idea to have locations for two capacitors in the layout for this reason).

$$C_{\text{CS(NEW)}} = C_{\text{CS(OLD)}} \times \frac{V_{\text{ACDRP}}}{V_{\text{DCDRP}}} \quad (\text{eq. 47})$$

7. Repeat Steps 5 and 6 until no adjustment of  $C_{\text{CS}}$  is needed. Once this is achieved, do not change  $C_{\text{CS}}$  for the rest of the procedure.
8. Set the dynamic load step to its maximum step size (but do not use a step size that is larger than needed) and verify that the output waveform is square, meaning  $V_{\text{ACDRP}}$  and  $V_{\text{DCDRP}}$  are equal.

9. Ensure that the load step slew rate and the power-up slew rate are set to  $\sim 150 \text{ A}/\mu\text{s}$  to  $250 \text{ A}/\mu\text{s}$  (for example, a load step of 50 A should take 200 ns to 300 ns) with no overshoot. Some dynamic loads have an excessive overshoot at power-up if a minimum current is incorrectly set (this is an issue if a VTT tool is in use).

#### Set the Initial Transient

1. With the dynamic load set at its maximum step size, expand the scope time scale to 2  $\mu\text{s}/\text{div}$  to 5  $\mu\text{s}/\text{div}$ . This results in a waveform that may have two overshoots and one minor undershoot before achieving the final desired value after  $V_{\text{DROOP}}$  (see Figure 29).

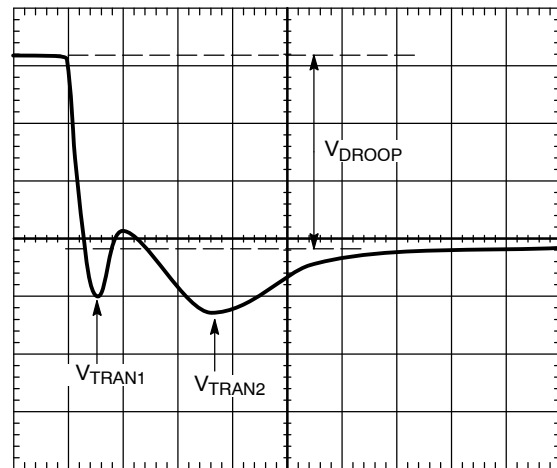
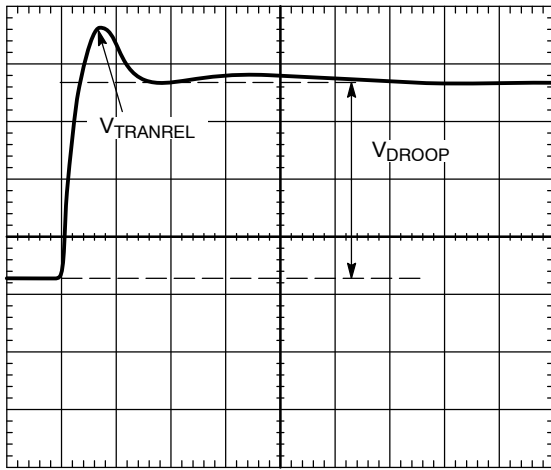


Figure 29. Transient Setting Waveform, Load Step

2. If both overshoots are larger than desired, try the following adjustments in the order shown.
  - a. Increase the resistance of the ramp resistor ( $R_{\text{RAMP}}$ ) by 25%.
  - b. For  $V_{\text{TRAN1}}$ , increase  $C_{\text{B}}$  or increase the switching frequency.
  - c. For  $V_{\text{TRAN2}}$ , increase  $R_{\text{A}}$  by 25% and decrease  $C_{\text{A}}$  by 25%.
 If these adjustments do not change the response, it is because the system is limited by the output decoupling. Check the output response and the switching nodes each time a change is made to ensure that the output decoupling is stable.
3. For load release (see Figure 30), if  $V_{\text{TRANREL}}$  is larger than the value specified by IMVP-6+, a greater percentage of output capacitance is needed. Either increase the capacitance directly or decrease the inductor values. (If inductors are changed, however, it will be necessary to redesign the circuit using the information from the spreadsheet and to repeat all tuning guide procedures).





**Figure 30. Transient Setting Waveform, Load Release**

### Layout and Component Placement

The following guidelines are recommended for optimal performance of a switching regulator in a PC system.

### General Recommendations

- For best results, use a PCB of four or more layers. This should provide the needed versatility for control circuitry interconnections with optimal placement; power planes for ground, input, and output; and wide interconnection traces in the rest of the power delivery current paths. Keep in mind that each square unit of 1 oz copper trace has a resistance of  $\sim 0.53 \text{ m}\Omega$  at room temperature.
- When high currents must be routed between PCB layers, vias should be used liberally to create several parallel current paths so that the resistance and inductance introduced by these current paths is minimized and the via current rating is not exceeded.
- If critical signal lines (including the output voltage sense lines of the ADP3209D) must cross through power circuitry, it is best if a signal ground plane can be interposed between those signal lines and the traces of the power circuitry. This serves as a shield to minimize noise injection into the signals at the expense of increasing signal ground noise.
- An analog ground plane should be used around and under the ADP3209D for referencing the components associated with the controller. This plane should be tied to the nearest ground of the output decoupling capacitor, but should not be tied to any other power circuitry to prevent power currents from flowing into the plane.
- The components around the ADP3209D should be located close to the controller with short traces. The most important traces to keep short and away from other traces are those to the FB and CSFB pins. Refer to Figure 25 for more details on the layout for the CSFB node.

- The output capacitors should be connected as close as possible to the load (or connector) that receives the power (for example, a microprocessor core). If the load is distributed, the capacitors should also be distributed and generally placed in greater proportion where the load is more dynamic.
- Avoid crossing signal lines over the switching power path loop, as described in the Power Circuitry section.

### Power Circuitry

- The switching power path on the PCB should be routed to encompass the shortest possible length to minimize radiated switching noise energy (that is, EMI) and conduction losses in the board. Failure to take proper precautions often results in EMI problems for the entire PC system as well as noise-related operational problems in the power-converter control circuitry. The switching power path is the loop formed by the current path through the input capacitors and the power MOSFETs, including all interconnecting PCB traces and planes. The use of short, wide interconnection traces is especially critical in this path for two reasons: it minimizes the inductance in the switching loop, which can cause high energy ringing, and it accommodates the high current demand with minimal voltage loss.
- When a power-dissipating component (for example, a power MOSFET) is soldered to a PCB, the liberal use of vias, both directly on the mounting pad and immediately surrounding it, is recommended. Two important reasons for this are improved current rating through the vias and improved thermal performance from vias extended to the opposite side of the PCB, where a plane can more readily transfer heat to the surrounding air. To achieve optimal thermal dissipation, mirror the pad configurations used to heat sink the MOSFETs on the opposite side of the PCB. In addition, improvements in thermal performance can be obtained using the largest possible pad area.
- The output power path should also be routed to encompass a short distance. The output power path is formed by the current path through the inductor, the output capacitors, and the load.
- For best EMI containment, a solid power ground plane should be used as one of the inner layers and extended under all power components.

### Signal Circuitry

- The output voltage is sensed and regulated between the FB and FBRTN pins, and the traces of these pins should be connected to the signal ground of the load. To avoid differential mode noise pickup in the sensed signal, the loop area

## ADP3209D

should be as small as possible. Therefore, the FB and FBRTN traces should be routed adjacent to each other, atop the power ground plane, and back to the controller.

2. The feedback traces from the switch nodes should be connected as close as possible to the inductor. The CSREF signal should be Kelvin connected to

the center point of the copper bar, which is the  $V_{CCGFx}$  common node for the inductor.

3. On the back of the ADP3209D package, there is a metal pad that can be used to heat sink the device. Therefore, running vias under the ADP3209D is not recommended because the metal pad may cause shorting between vias.

### ORDERING INFORMATION

| Device          | Temperature Range | Package                                    | Package Option | Shipping†          |
|-----------------|-------------------|--------------------------------------------|----------------|--------------------|
| ADP3209DJCPZ-RL | 0°C to 100°C      | 32-Lead Frame Chip Scale Package [LCSP_VQ] | CP-32-2        | 5000 / Tape & Reel |

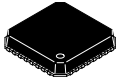
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

\*The "Z" suffix indicates Pb-Free part.

# MECHANICAL CASE OUTLINE

## PACKAGE DIMENSIONS

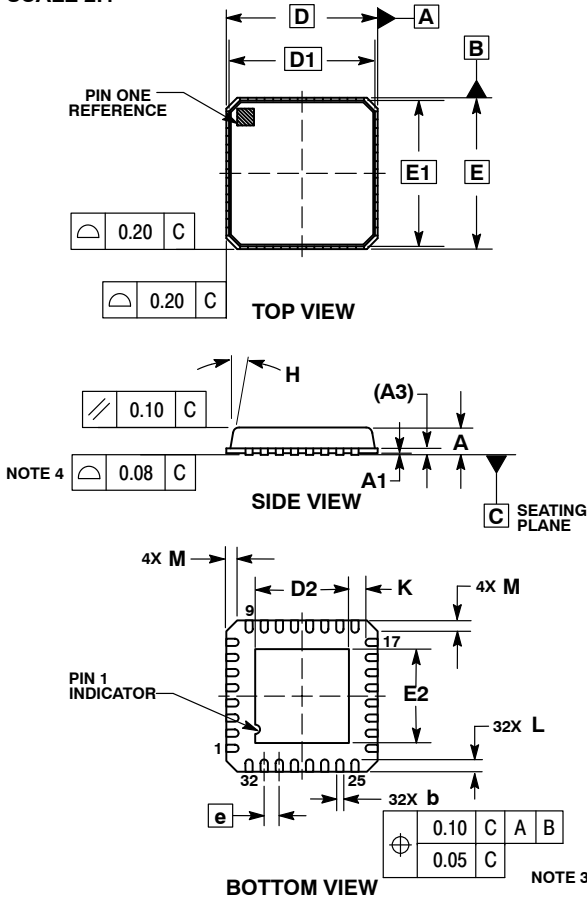
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**LFCSP32 5x5, 0.5P**  
CASE 932AE-01  
ISSUE A

DATE 27 JAN 2009

SCALE 2:1

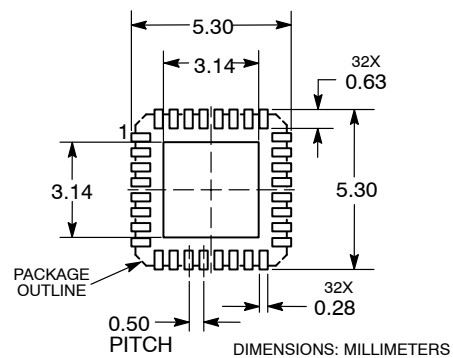


**NOTES:**

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSIONS: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM THE TERMINAL TIP.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

| DIM | MILLIMETERS |      |
|-----|-------------|------|
|     | MIN         | MAX  |
| A   | 0.80        | 1.00 |
| A1  | 0.00        | 0.05 |
| A3  | 0.20        | REF  |
| b   | 0.18        | 0.30 |
| D   | 5.00        | BSC  |
| D1  | 4.75        | BSC  |
| D2  | 2.95        | 3.25 |
| E   | 5.00        | BSC  |
| E1  | 4.75        | BSC  |
| E2  | 2.95        | 3.25 |
| e   | 0.50        | BSC  |
| H   | ---         | 12°  |
| K   | 0.20        | ---  |
| L   | 0.30        | 0.50 |
| M   | ---         | 0.60 |

**SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

|                         |                           |                                                                                                                                                                                  |
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